

An Investigation into the Role of Energy and Symmetry at Epitaxial Interfaces

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Outline

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Introduction

2

Background

- Theoretical
- Experimental

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Symmetry Breaking at Interfaces

- Twins and Epitaxy on Vicinal (Offcut) (001) Silicon
- Tilted Epitaxy on (211) Silicon

4

Unusual Bond Energies at Interfaces

- CdTe on Sapphire Epitaxy and Liftoff

5

Conclusions

Introduction

- Epitaxy from the greek *epi* (above) and *taxis* (in an ordered manner) is the process of growing one crystal on another
- Prior work in epitaxy has concentrated on systems with:
 - Identical crystal structure
 - Very similar crystal structure
 - Small lattice mismatch
- This work examines some examples of epitaxy where:
 - Large lattice mismatch
 - Very different crystal structures
 - Very different thermal expansion coefficients
- By investigating these cases, we hope to improve overall epitaxy of mismatched material systems

Introduction

- Epitaxy from the greek *epi* (above) and *taxis* (in an ordered manner) is the process of growing one crystal on another
- Prior work in epitaxy has concentrated on systems with:
 - Identical crystal structure
 - Nearly lattice matched spacings (unit cells of the same or comparable size)
 - Chemically similar properties (metal-metal, semiconductor-semiconductor)
- This work examines some examples of epitaxy where:
 - Mismatches in crystal structure
 - Differences in lattice spacings
 - Differences in chemical properties
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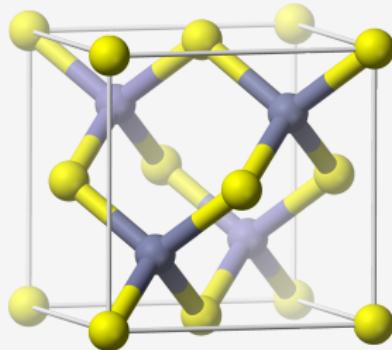
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Symmetry



Wikipedia: Zincblende

Symmetry

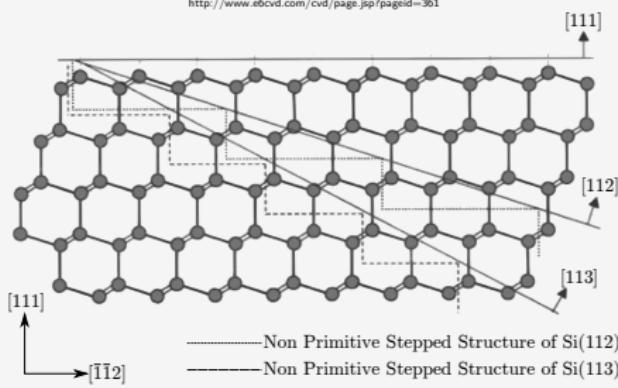


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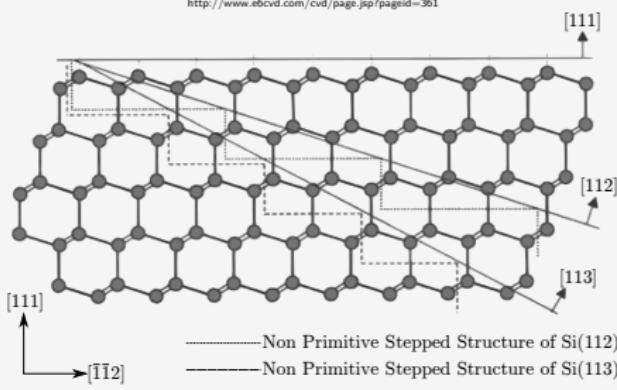


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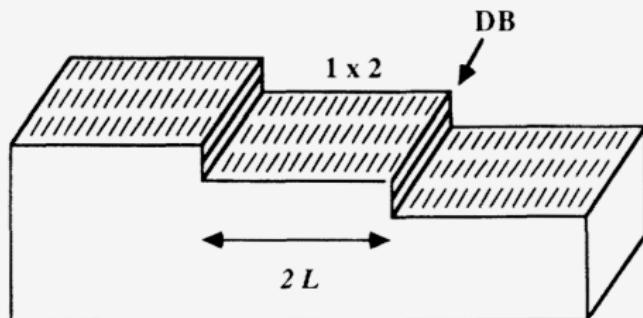
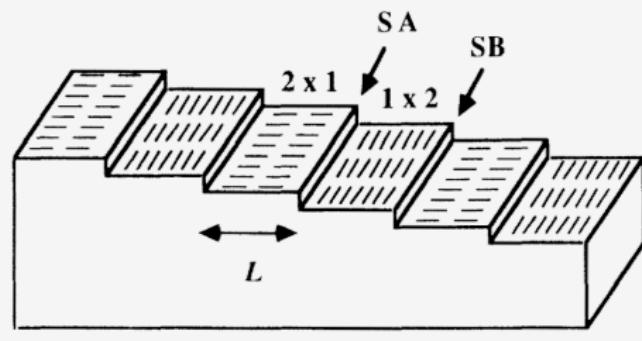
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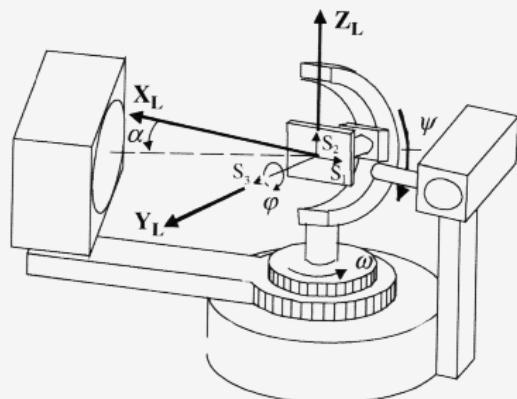


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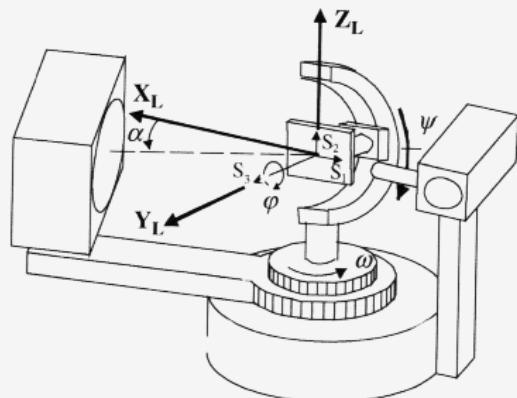
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2D X-Ray Diffraction and Pole Figures

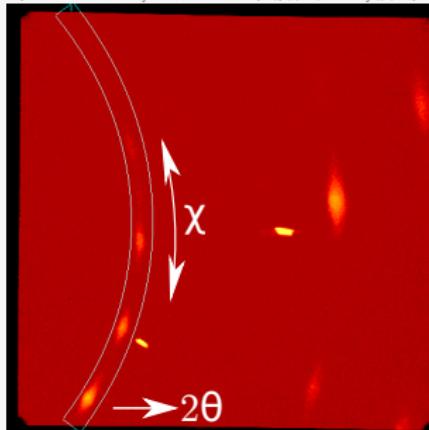


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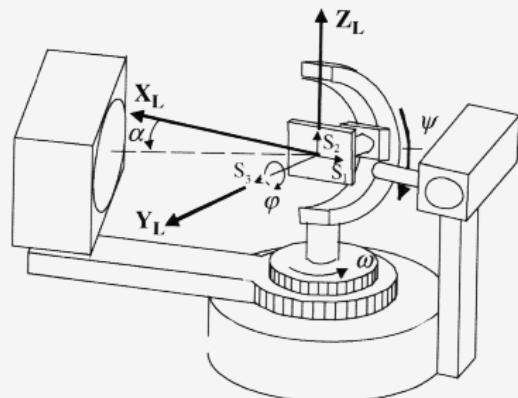
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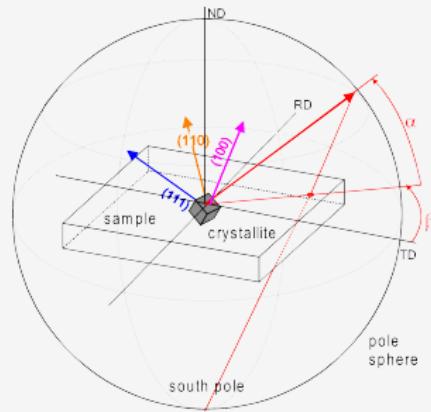
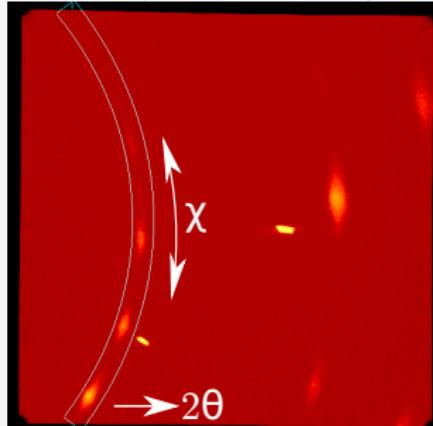
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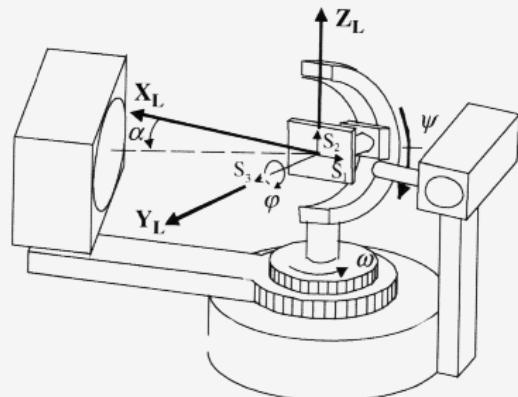


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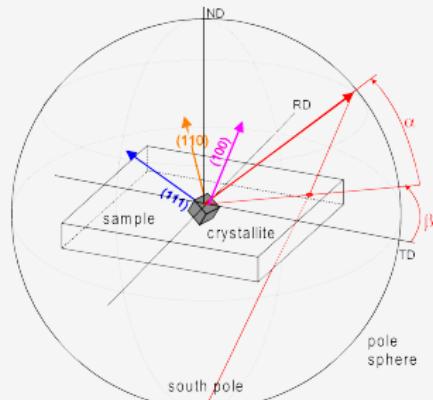
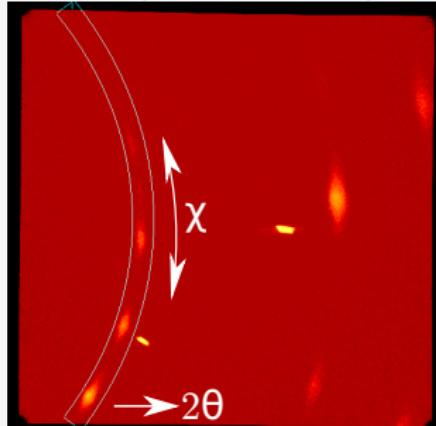


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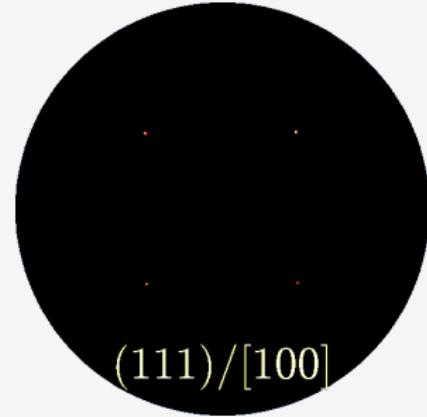
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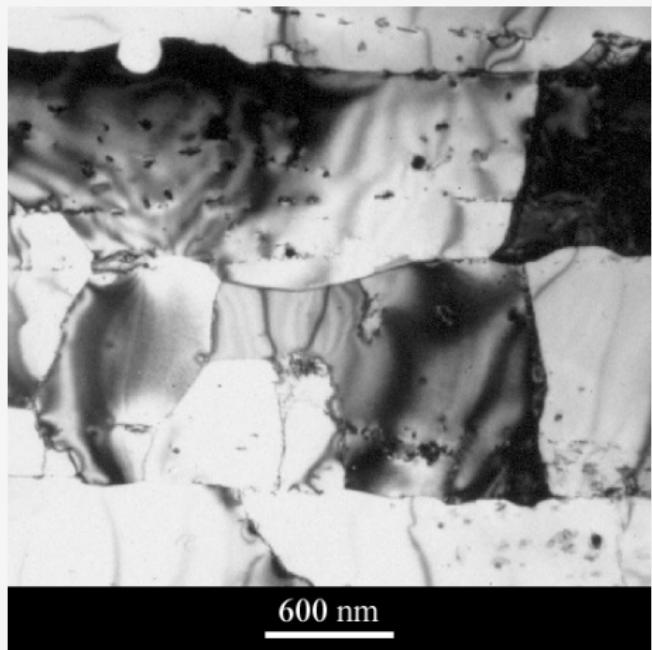
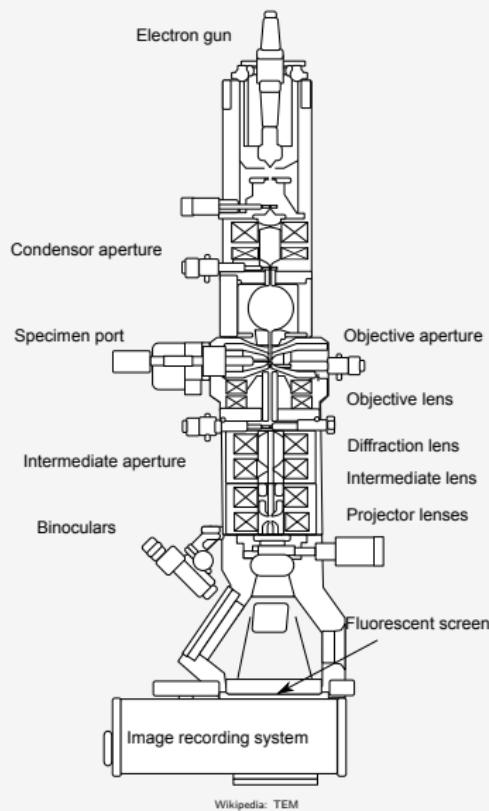
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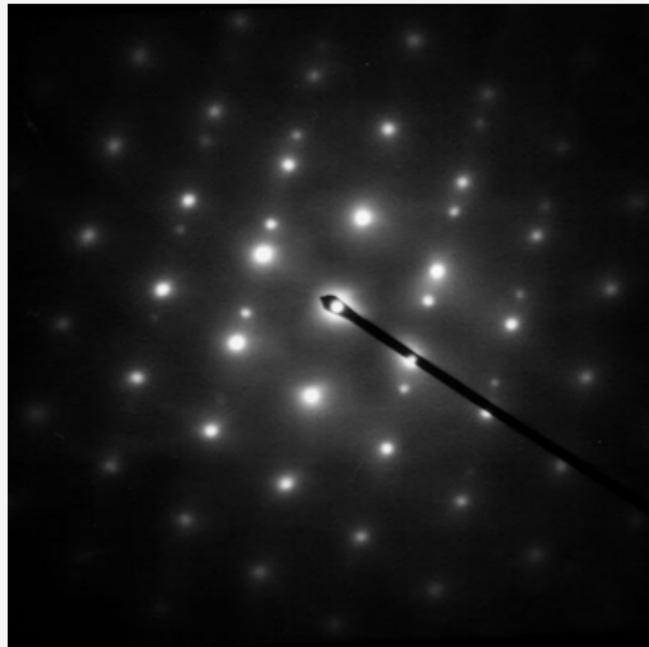
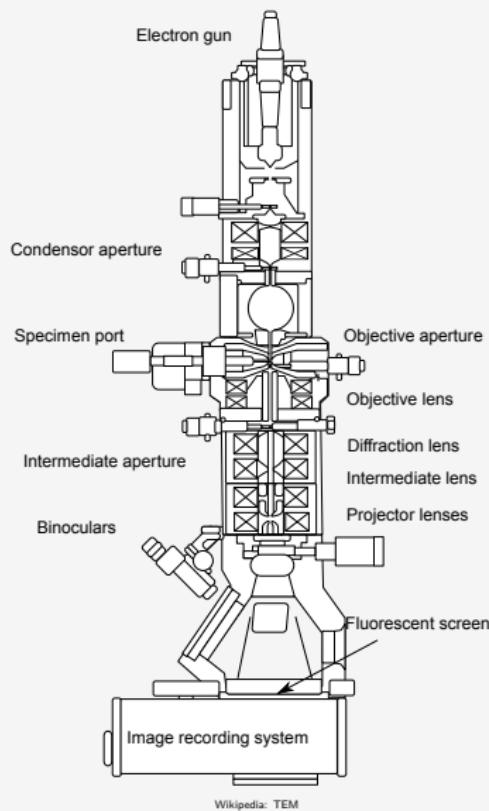
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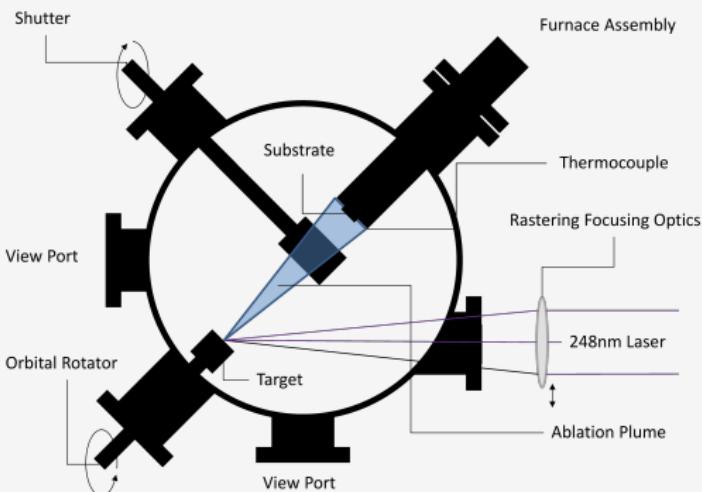


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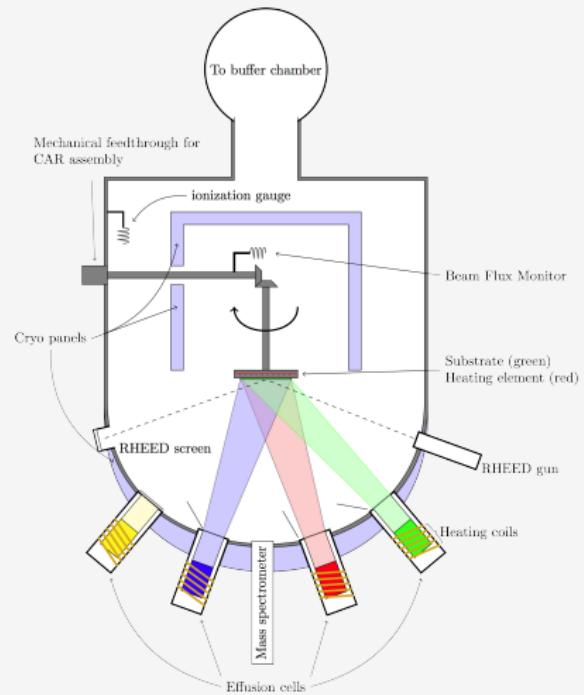


Wikipedia: TEM

Growth



Pulsed Laser Deposition (PLD)



Molecular Beam Epitaxy (MBE)

Wikipedia: MBE

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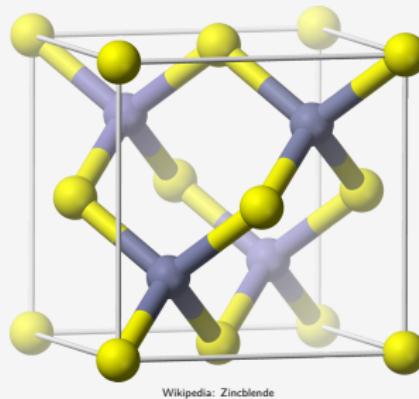
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5 Conclusions

Twins and Epitaxy on Vicinal (001) Silicon

Introduction

- Semiconductors are most commonly the zincblende crystal structure
- Twins (stacking faults on $<111>$ planes) are common low energy defects
- Investigations into III-V epitaxy showed a relationship between vicinal (offcut) substrates and twinning

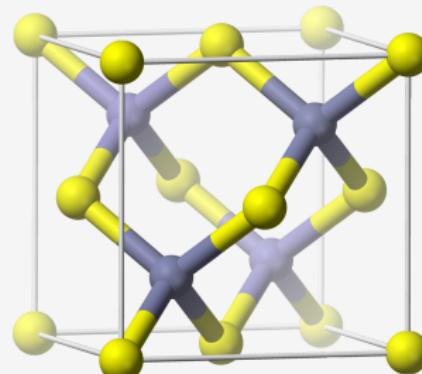


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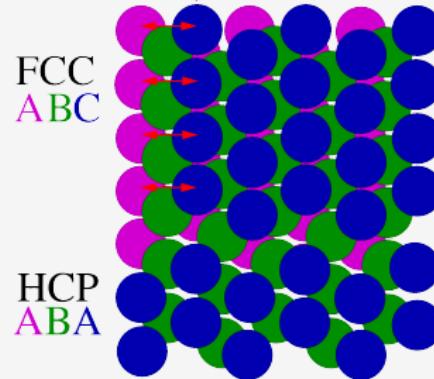
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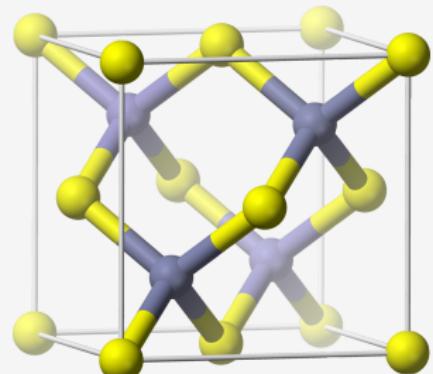


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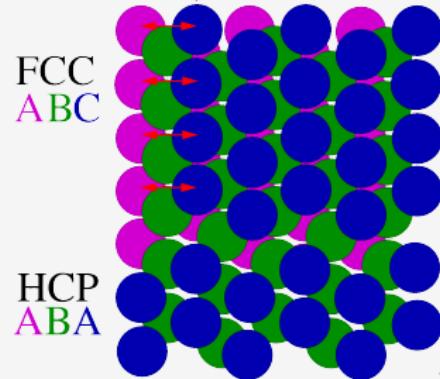
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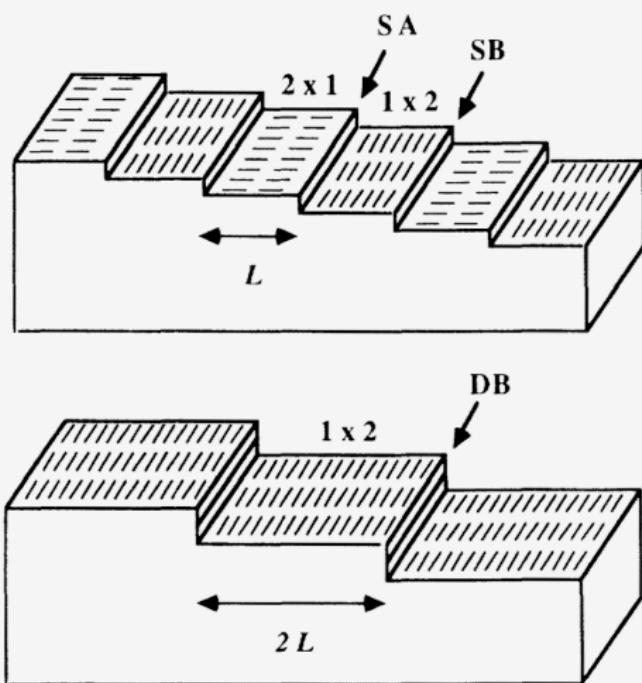


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Experimental

- Nominal (flat) and vicinal (off-cut) silicon (001) substrates
- Initially investigated due to their ability to control anti-phase boundaries in III-V epitaxy via step formation
- Substrates were reconstructed *in-situ* in the MBE via thermal treatment
- 500 nm films of GaAs, InP, GaSb, and AlSb were deposited, covering a lattice mismatch of 4–13%

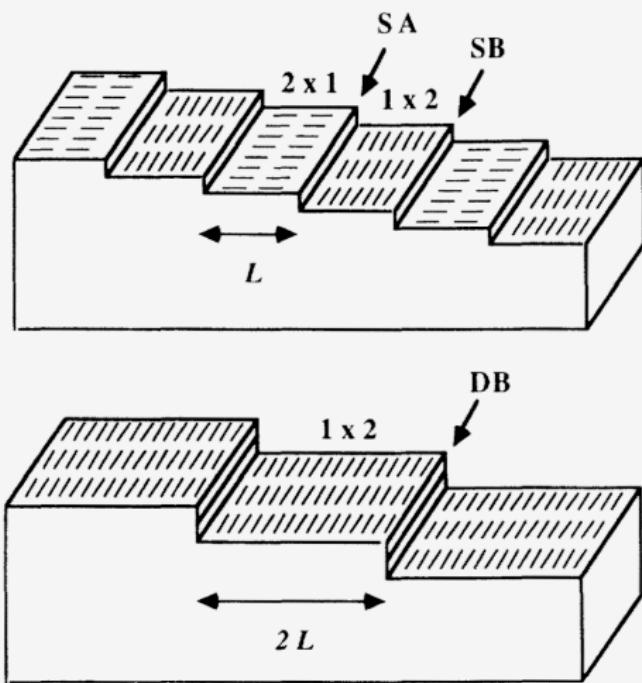


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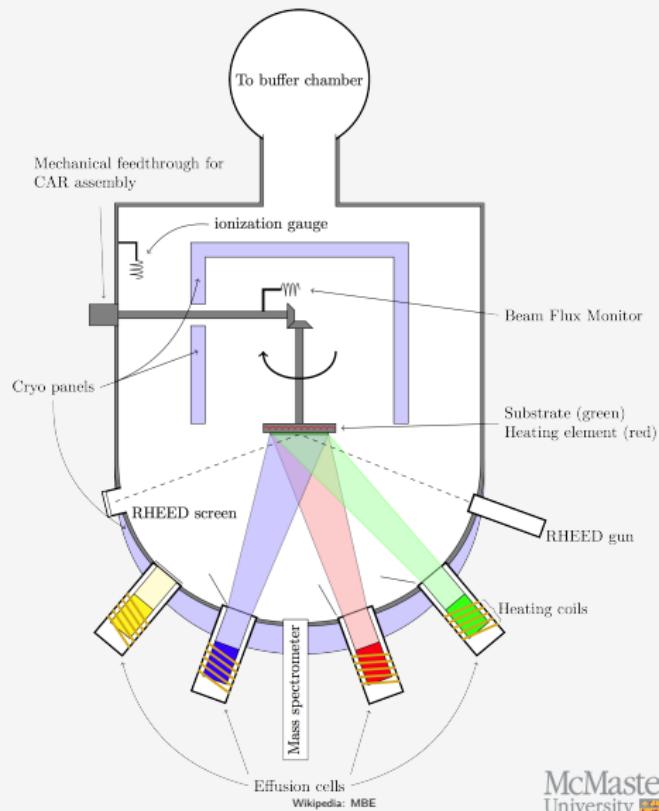


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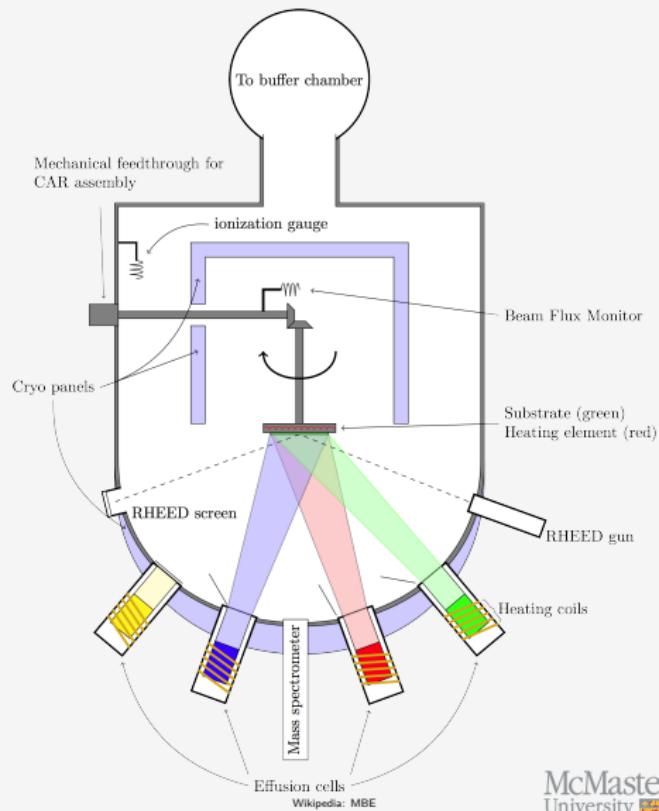
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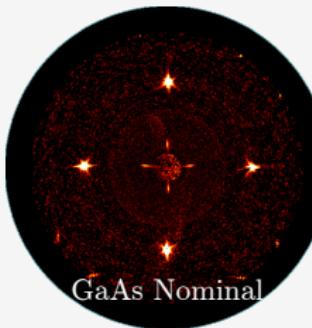
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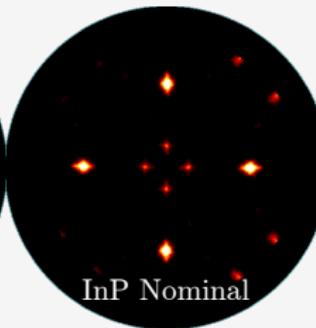
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(111) 2DXRD Pole Figures



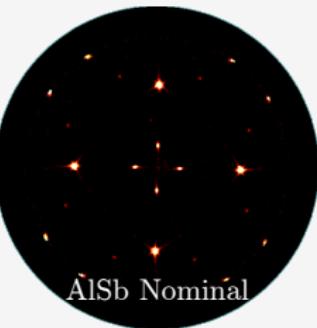
GaAs Nominal



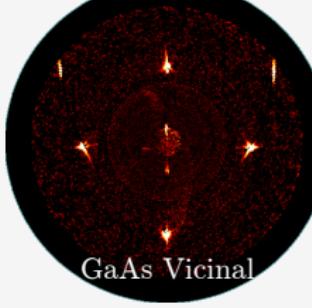
InP Nominal



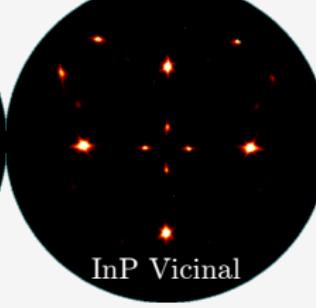
GaSb Nominal



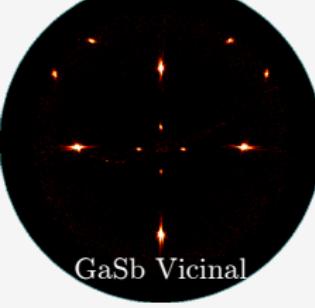
AlSb Nominal



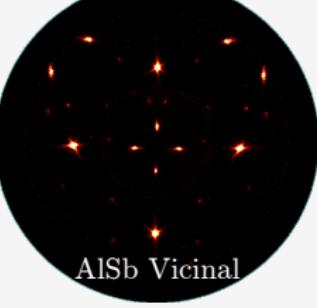
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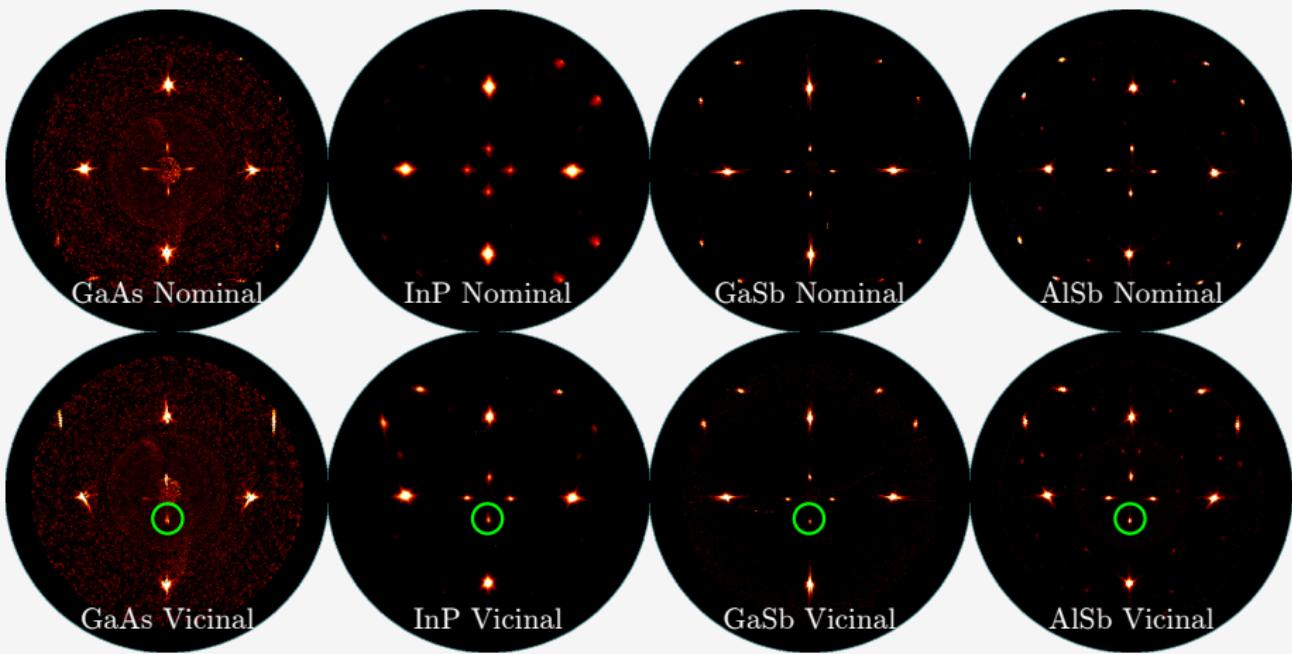


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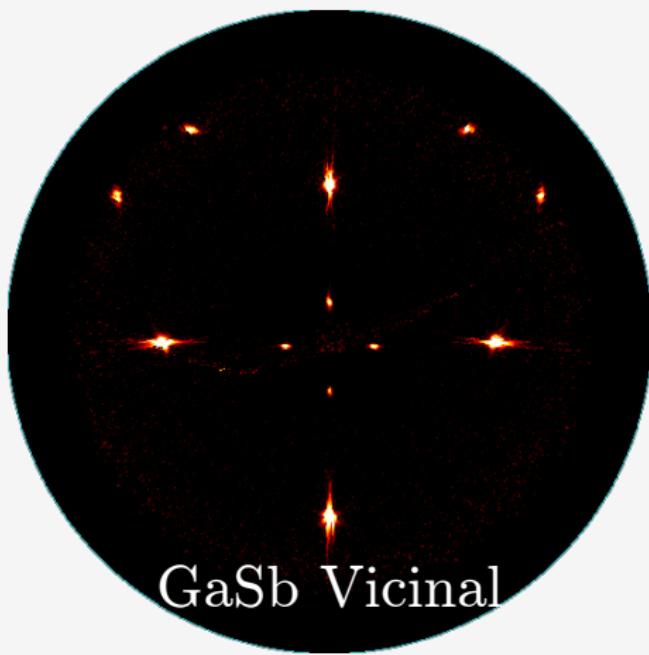
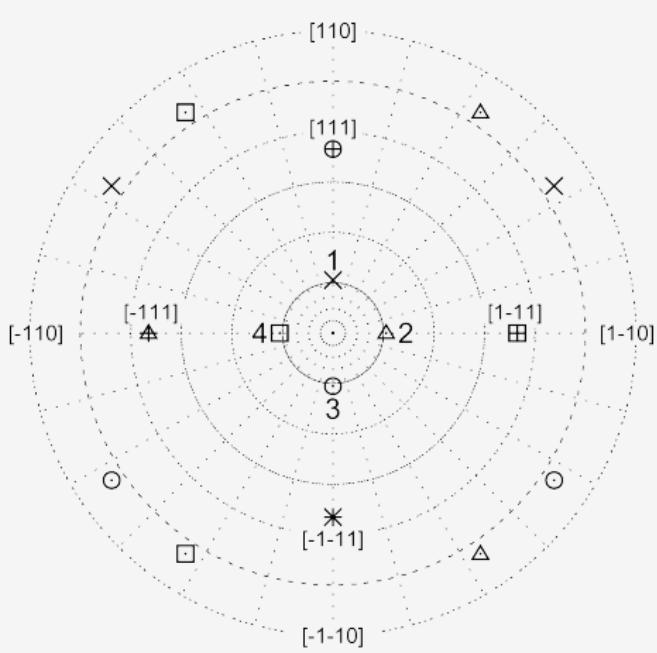


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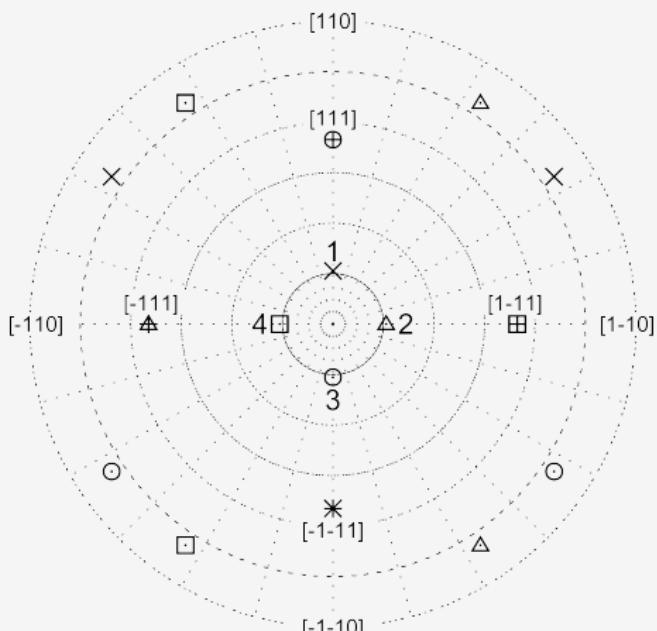
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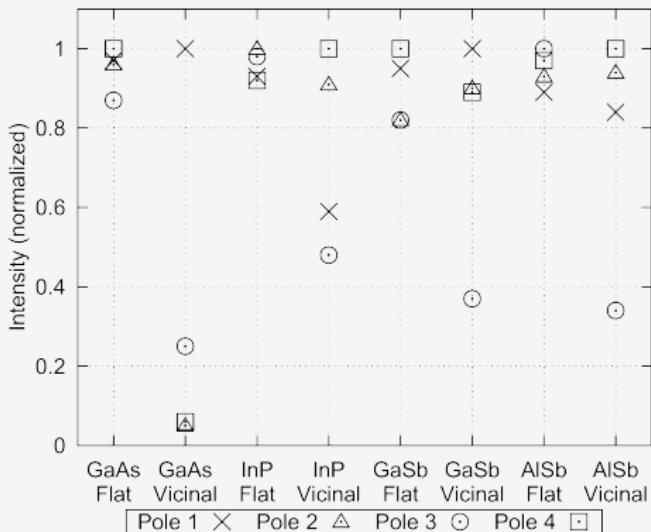
(111) Pole Figure Modelling and Intensity



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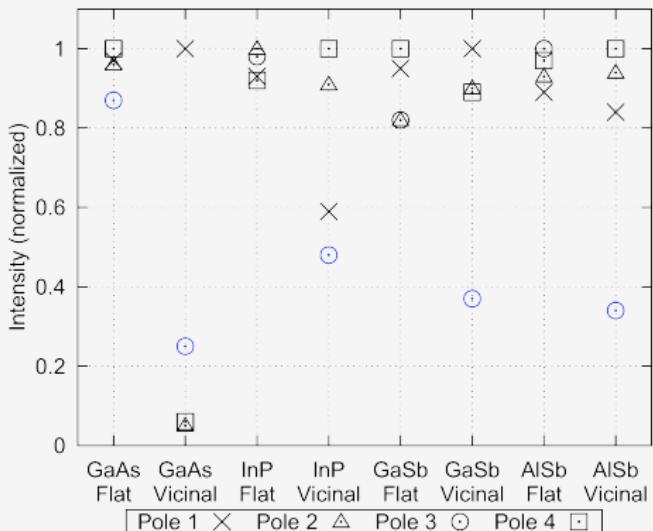
(100)	+	(111) Habit Plane	○
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(1-11) Habit Plane	□		



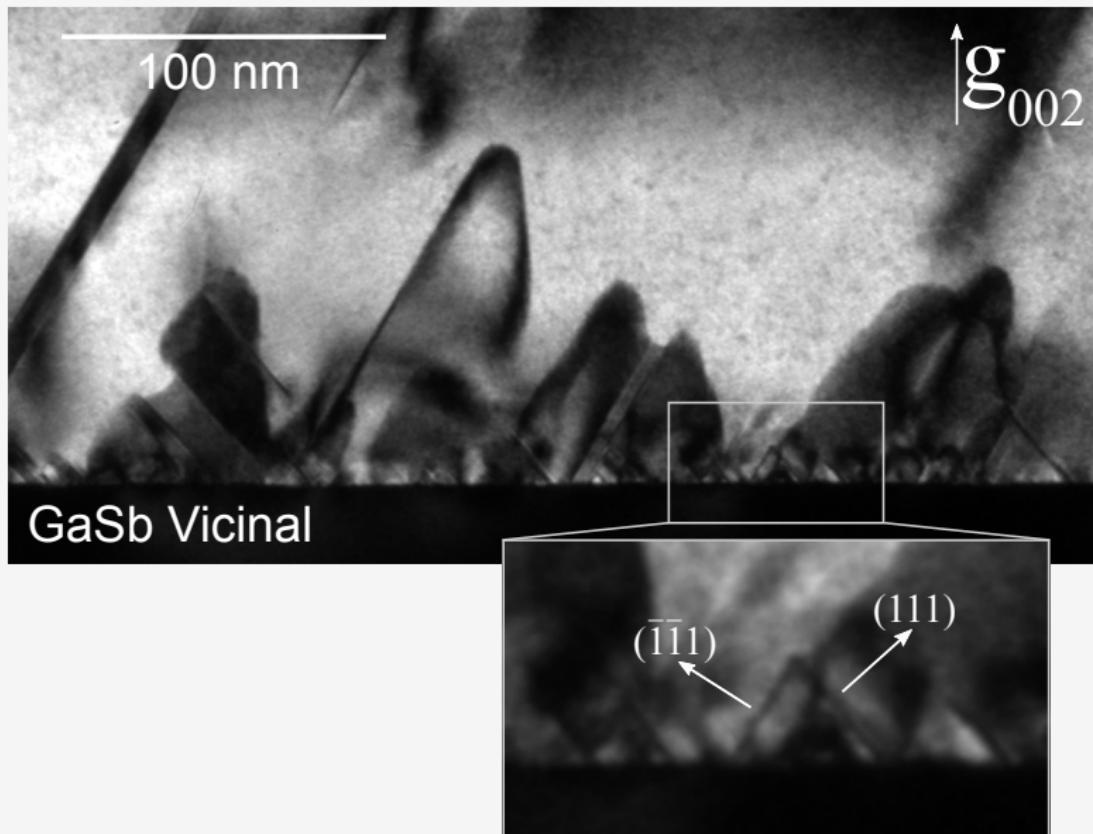
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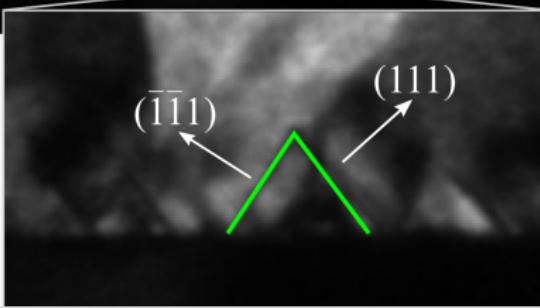
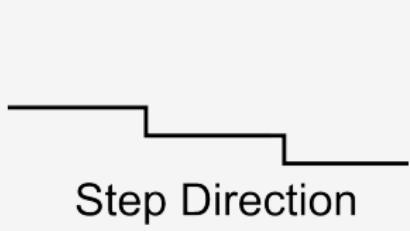
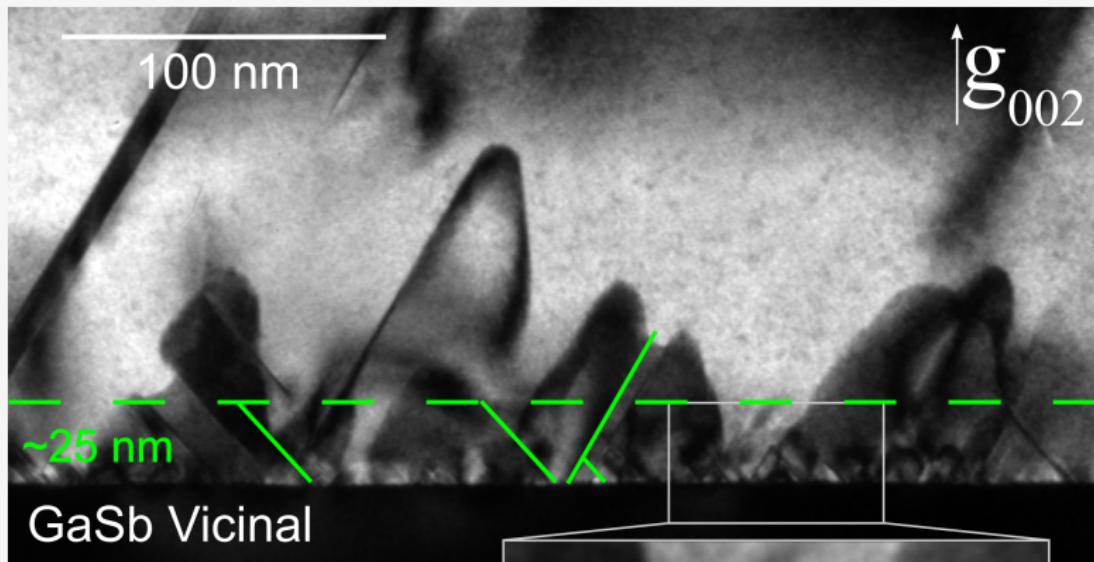
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(110) TEM



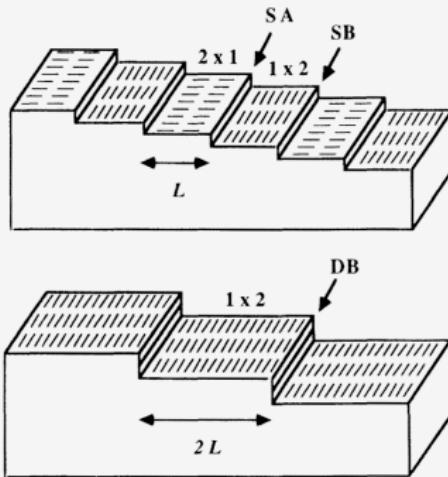
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Twins Epitaxy on Vicinal (001) Silicon

Conclusions

- Twins form on all $<111>$ surfaces
- Vicinal substrates cause asymmetric step formation in (001) silicon substrates
- Steps on the surface enhances the growth rate away from step edges
- Asymmetric growth rate overgrows twins limiting to a thin layer at the interface

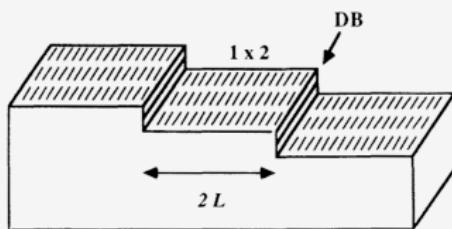
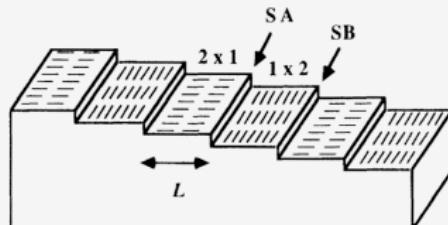


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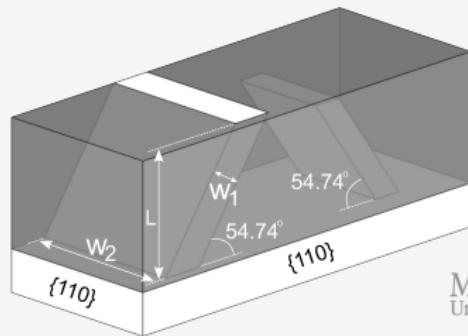
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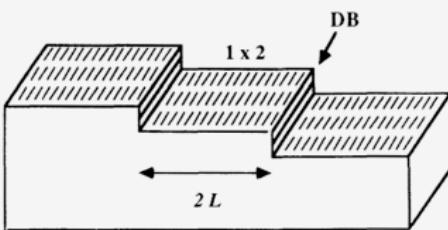
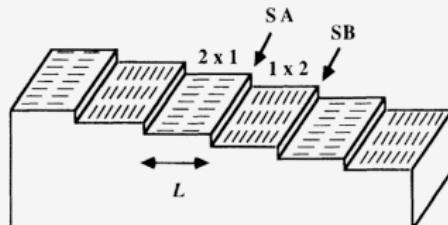
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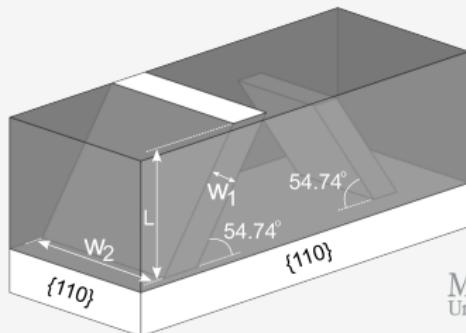
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- Twins form on all $<111>$ surfaces
- Vicinal substrates cause asymmetric step formation in (001) silicon substrates
- **Steps on the surface enhances the growth rate away from step edges**
- Asymmetric growth rate overgrows twins limiting to a thin layer at the interface



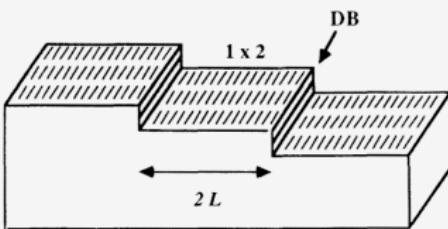
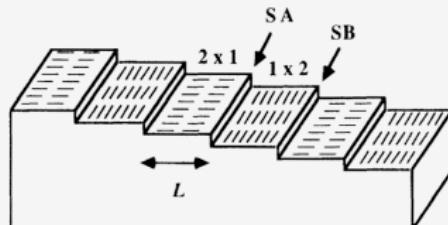
O. Alerhand, et. al., Phys. Rev. Lett., vol. 64, no. 20, pp. 2406–2409, May 1990.



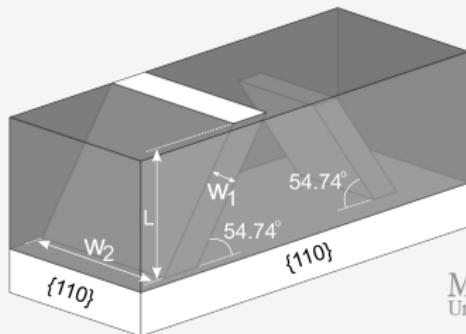
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Outline

1 Introduction

2 Background

- Theoretical
- Experimental

3 Symmetry Breaking at Interfaces

- Twins and Epitaxy on Vicinal (Offcut) (001) Silicon
- Tilted Epitaxy on (211) Silicon

4 Unusual Bond Energies at Interfaces

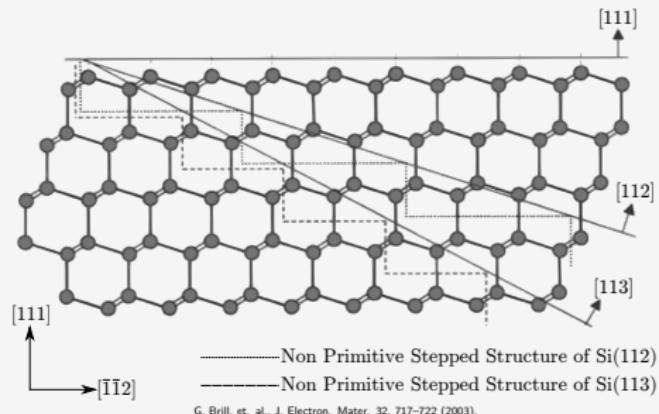
- CdTe on Sapphire Epitaxy and Liftoff

5 Conclusions

Tilted Epitaxy on (211) Silicon

Introduction

- The (211) surface of cubic diamond crystals are asymmetric, exhibiting atomic stepping
- (211) surfaces also have two non-equivalent lattice sites for zincblende semiconductor nucleation
- (211) substrates were initially investigated to solve the polar on non-polar problem of binary growth on silicon

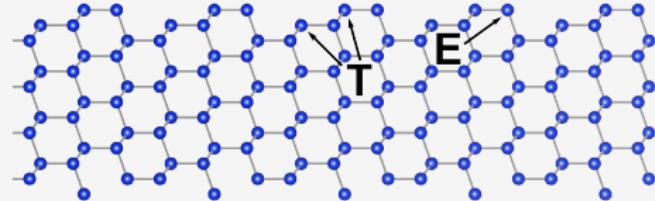
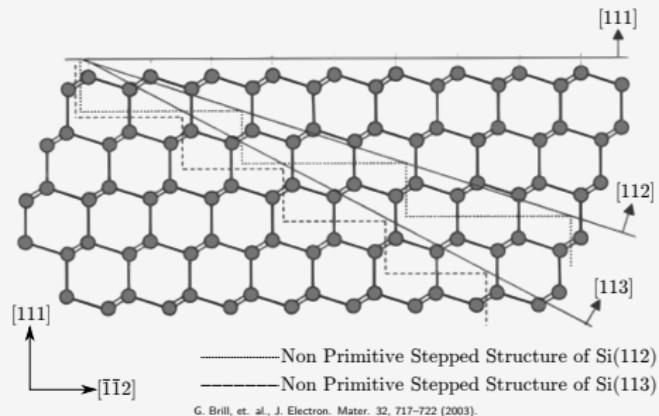


G. Brill, et. al., J. Electron. Mater. 32, 717–722 (2003).

Tilted Epitaxy on (211) Silicon

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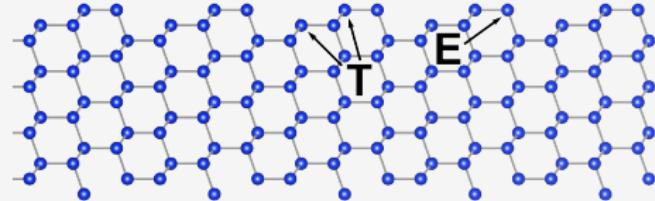
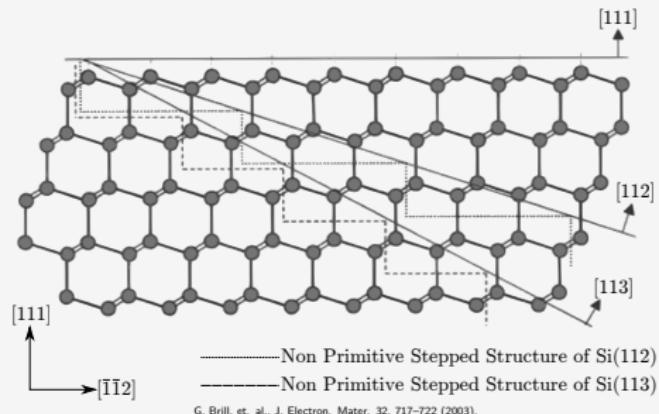
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Tilted Epitaxy on (211) Silicon

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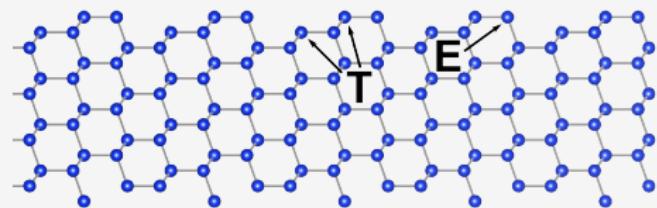
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Tilted Epitaxy on (211) Silicon

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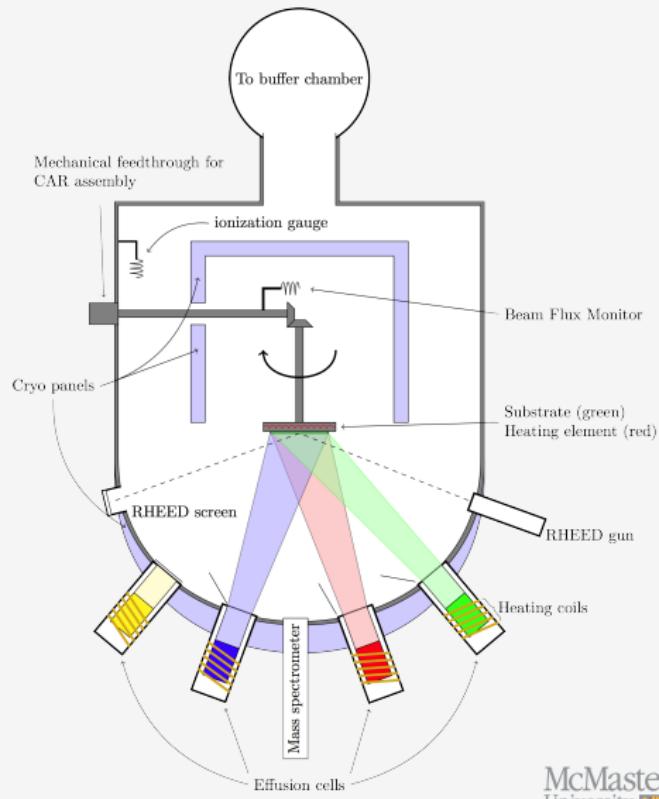
- (211) silicon substrates
- 500 nm films of GaSb were deposited in MBE
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Tilted Epitaxy on (211) Silicon

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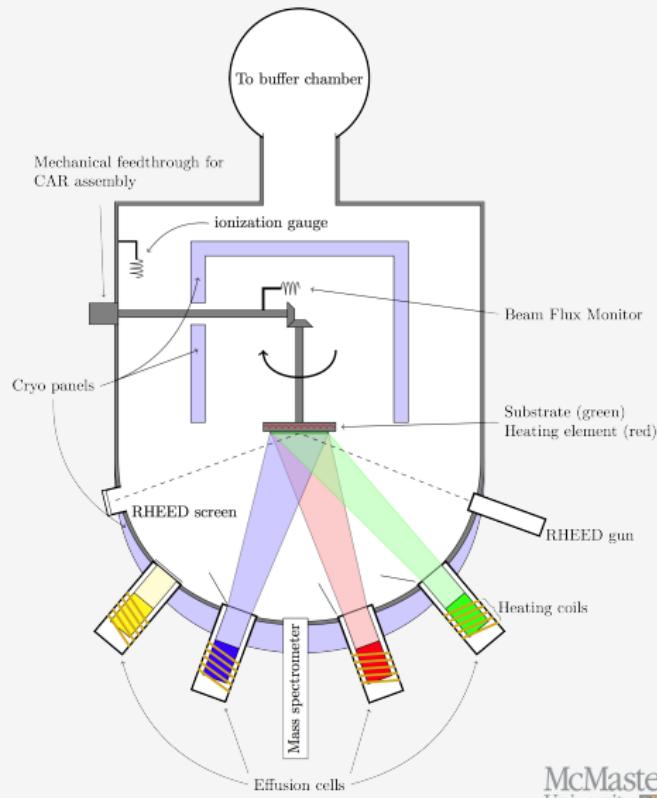
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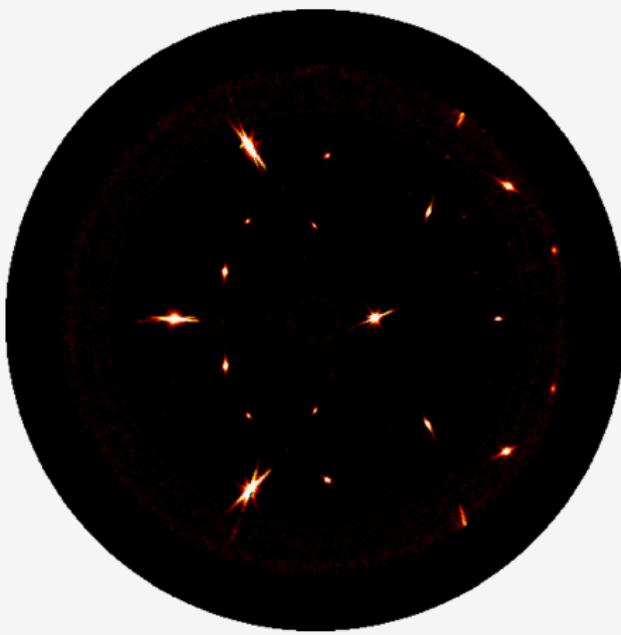
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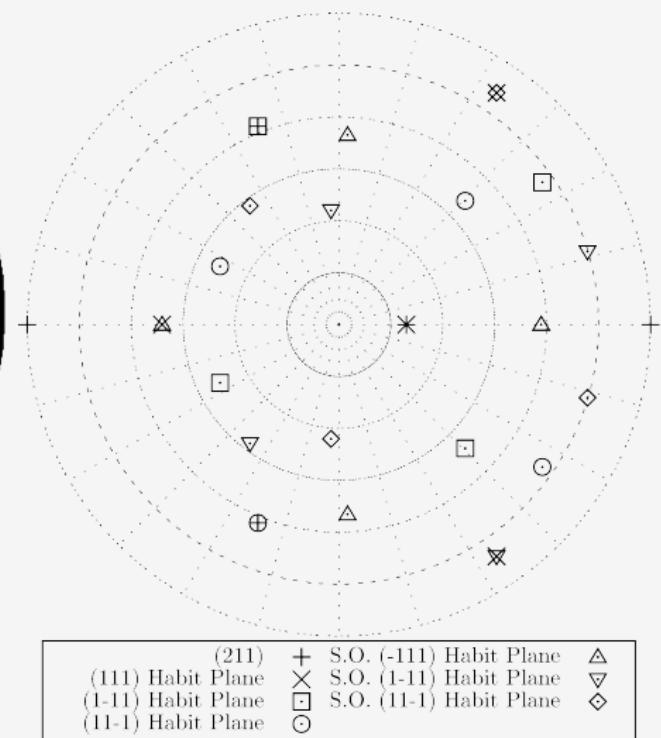
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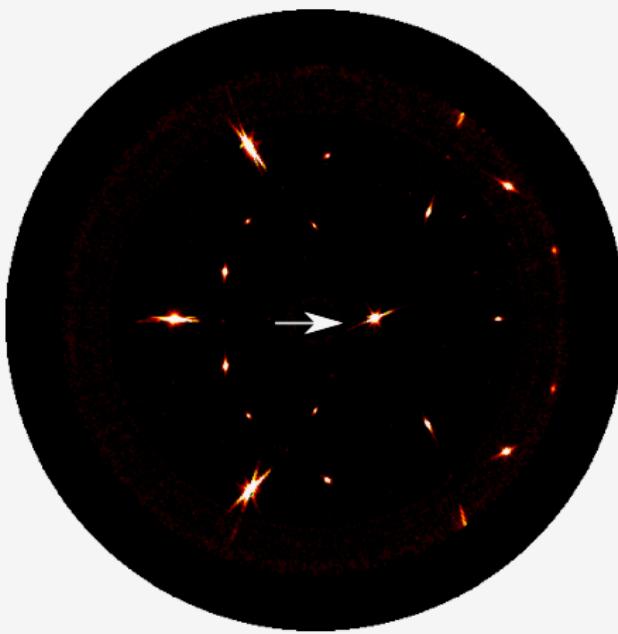


(a) Measured

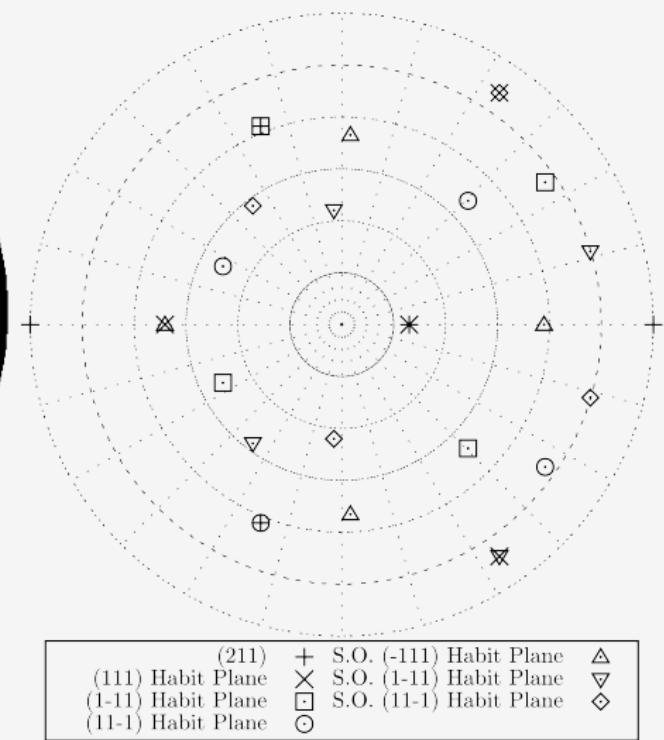


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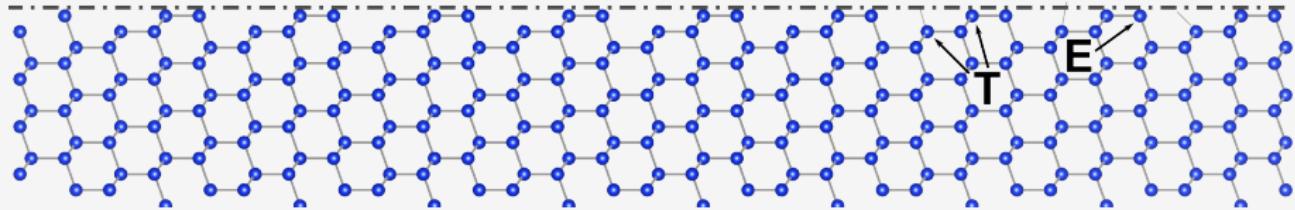


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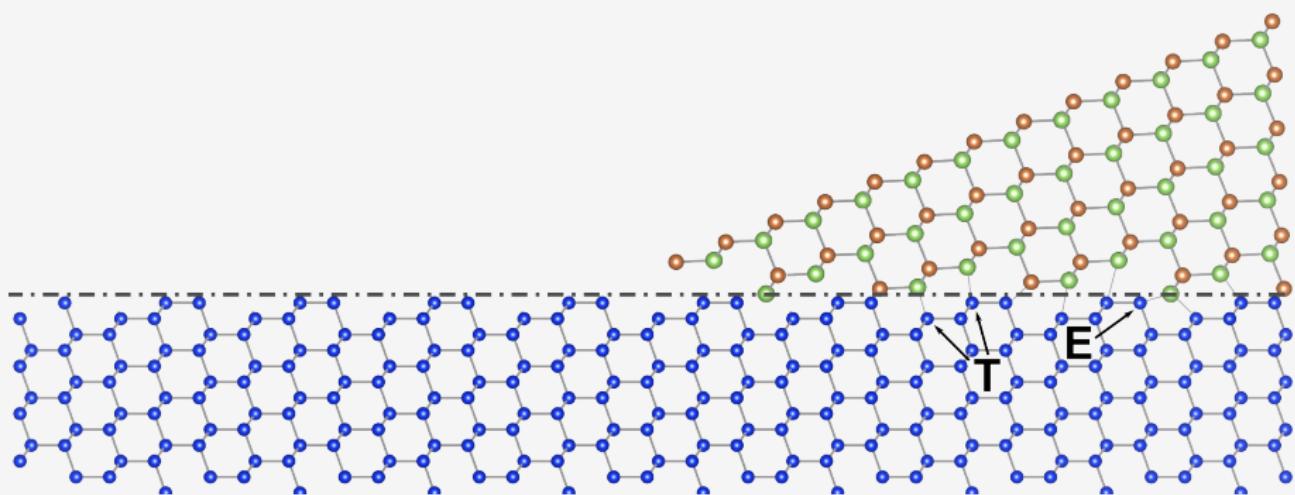


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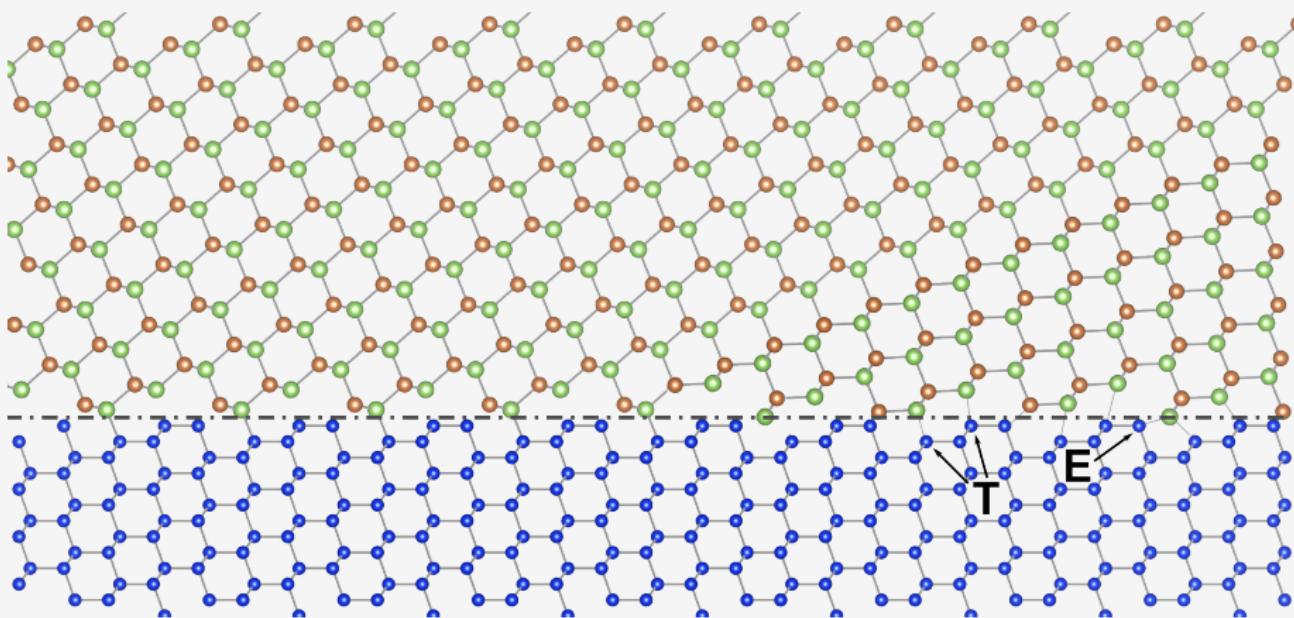
A Toy Model



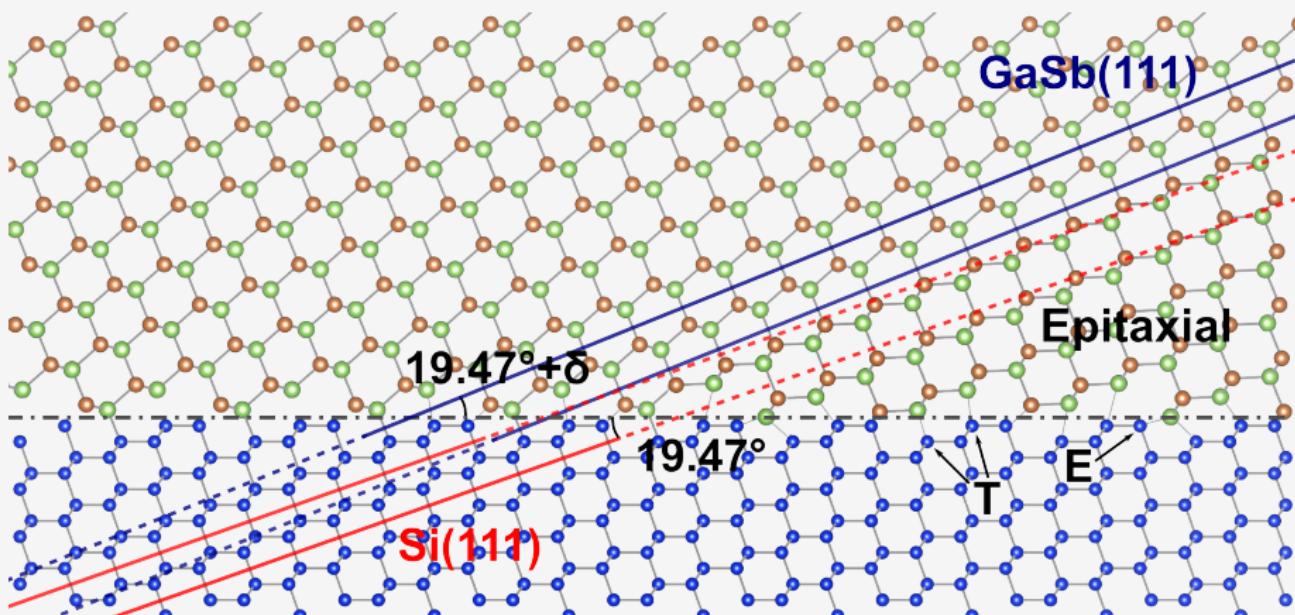
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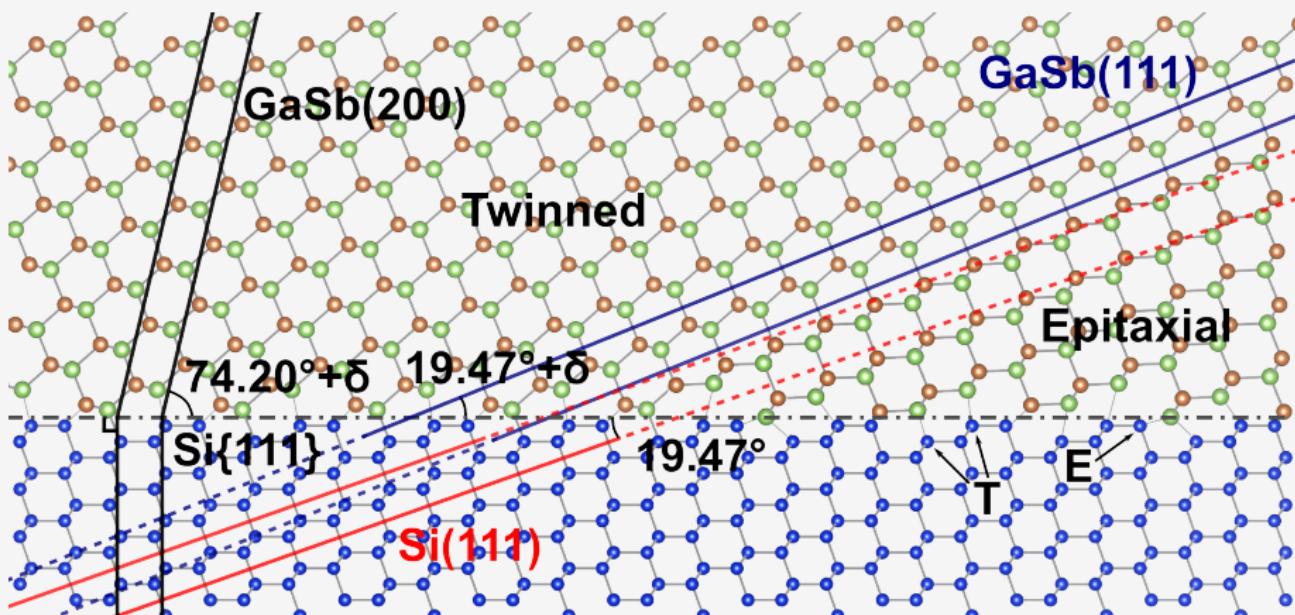


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- Equate d-spacing of Silicon with projected d-spacing of GaSb
- Generalize for any film and substrate combination
- Strain for an arbitrary tilt is the difference between two plane spacing

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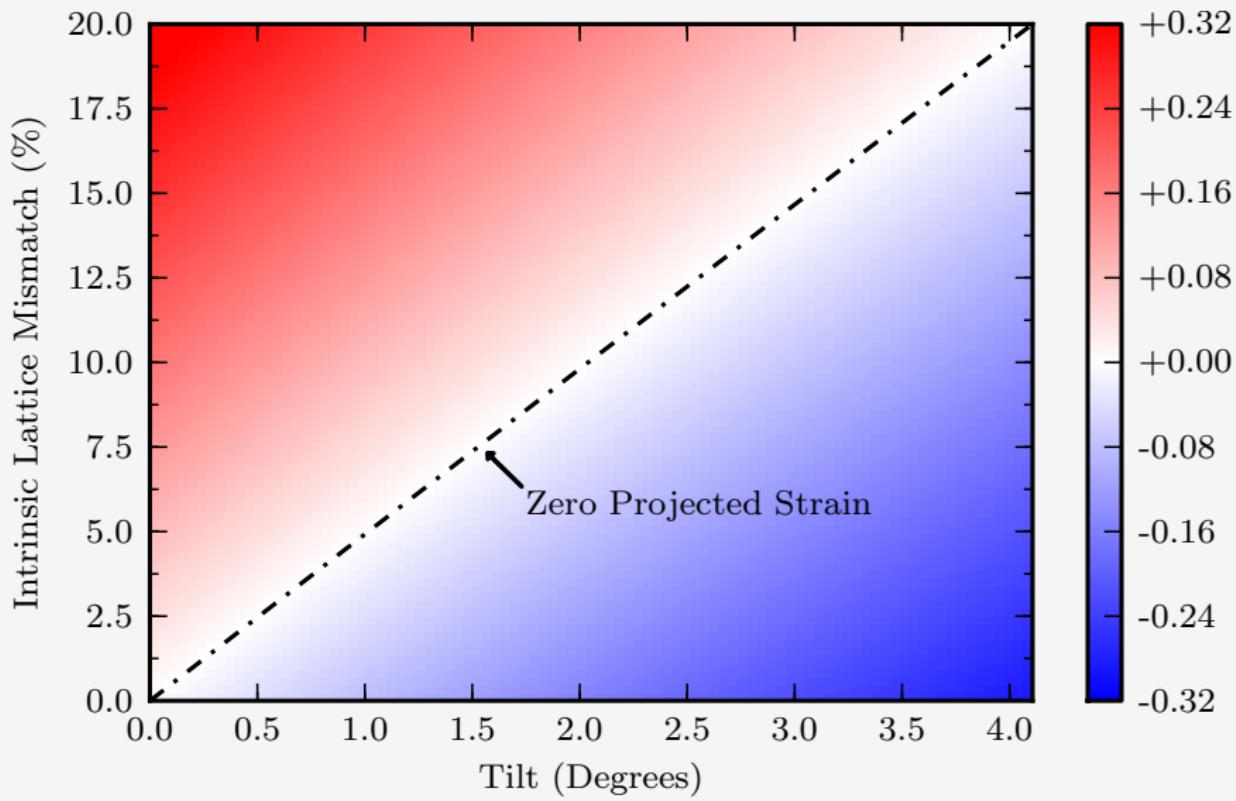
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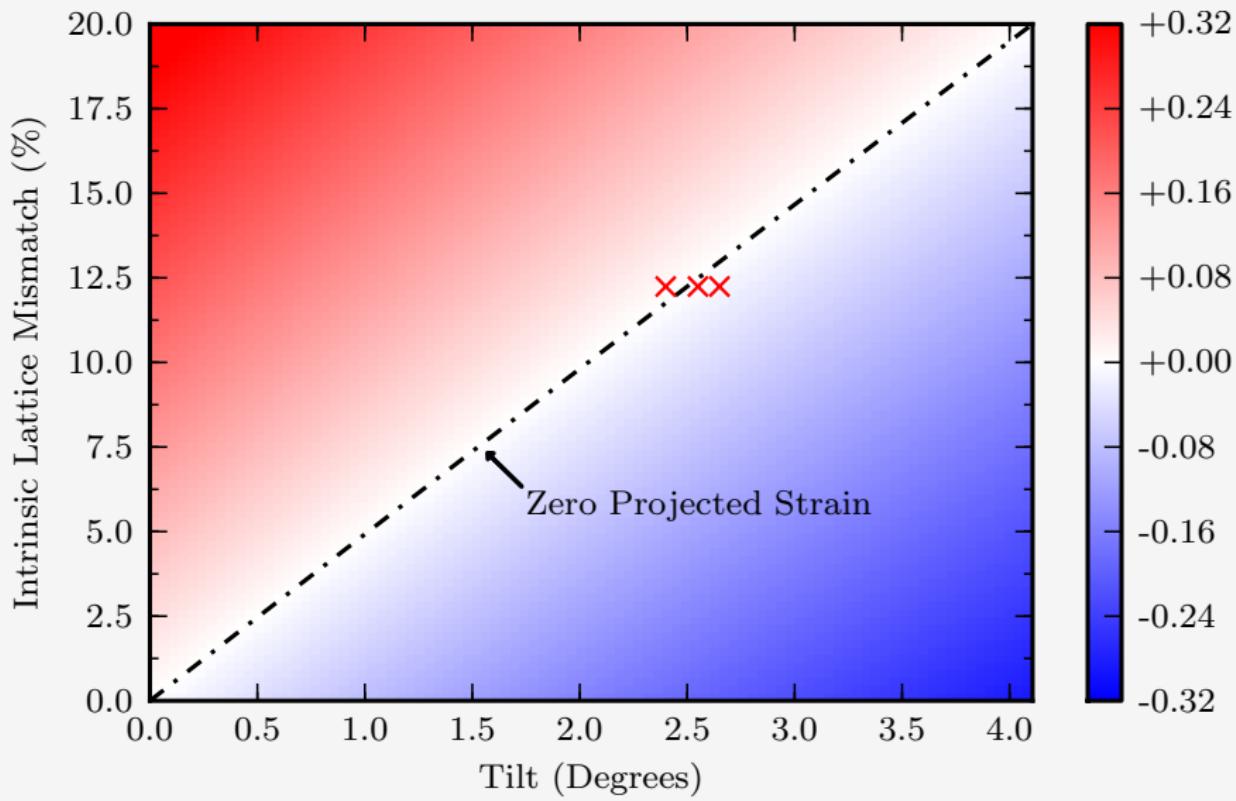
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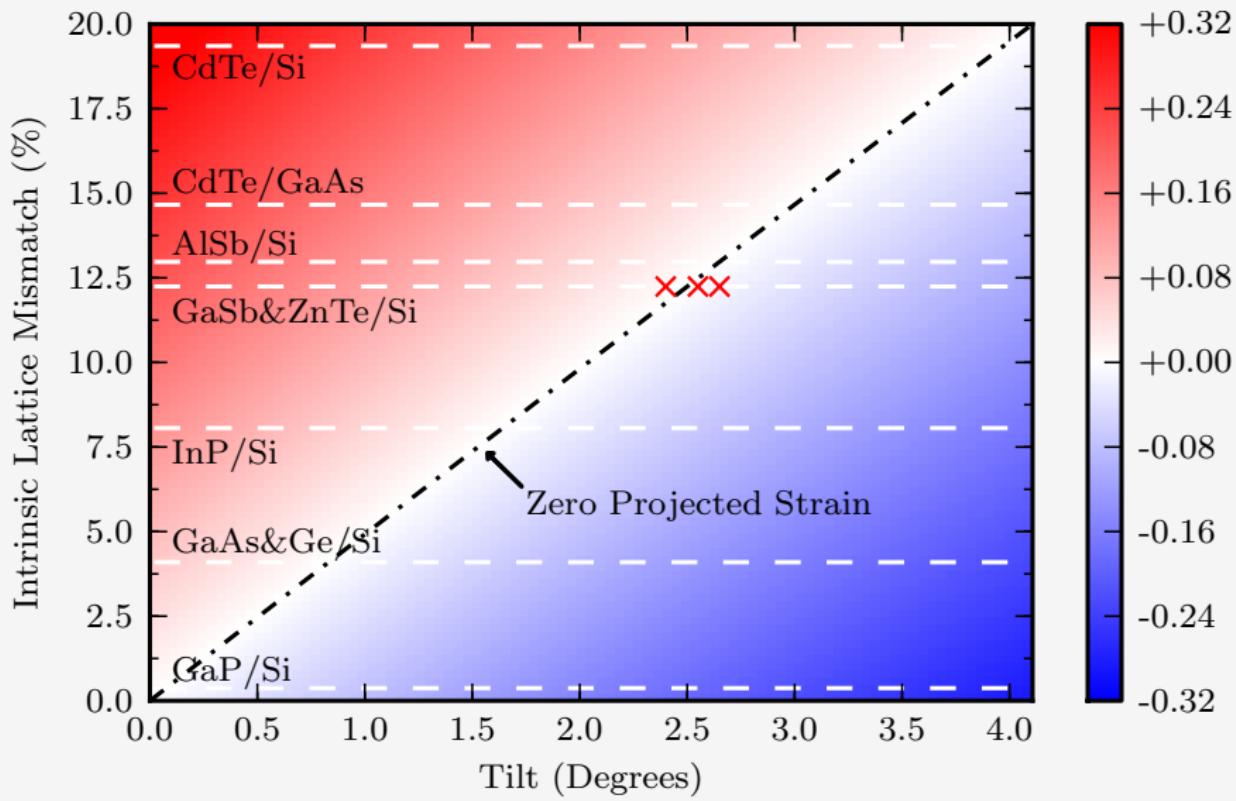
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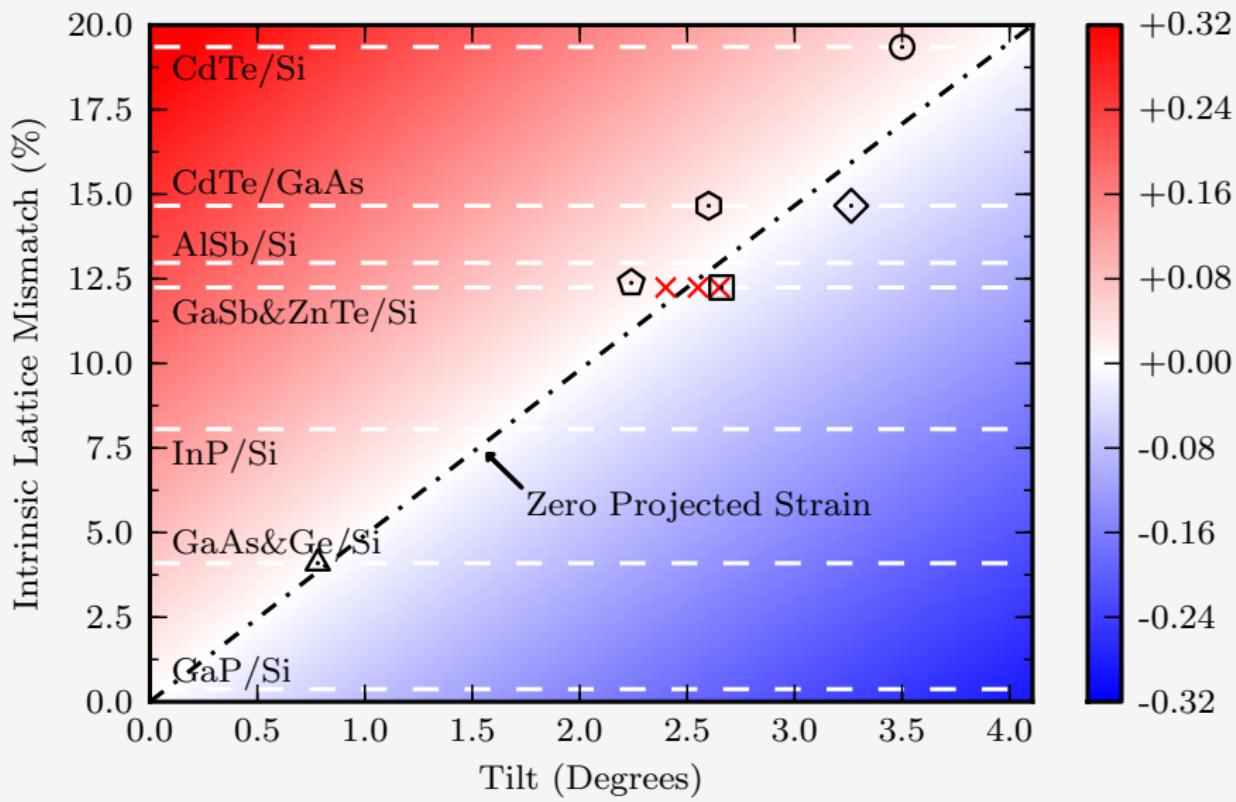
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$$\varepsilon = \frac{a_{film}}{\sqrt{3} \sin(19.471^\circ + \delta)} - \frac{a_{sub}}{\sqrt{3} \sin(19.471^\circ)}$$









Epitaxy on (211) Silicon

Conclusions

- The natural asymmetry of (211) allows the accommodation of strain by tilting on an axis perpendicular to the asymmetry
- Tilt is driven by the alignment of (111) planes between the substrate and the thin film
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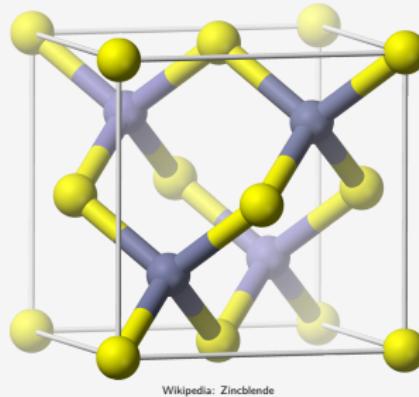
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Introduction

Unusual Bond Energies

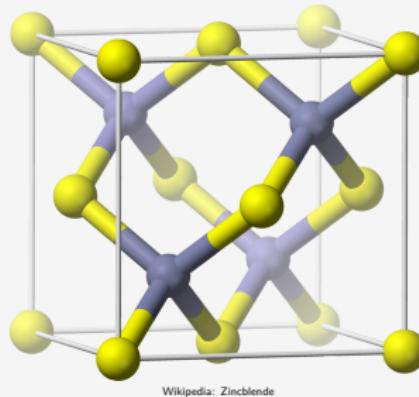
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Introduction

Unusual Bond Energies

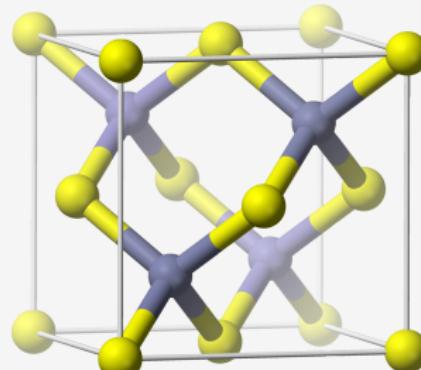
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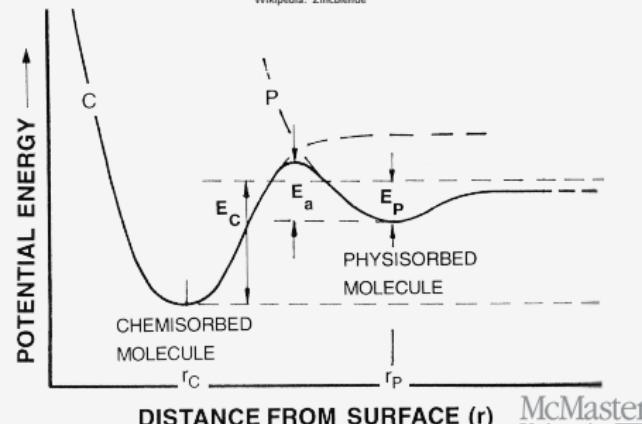
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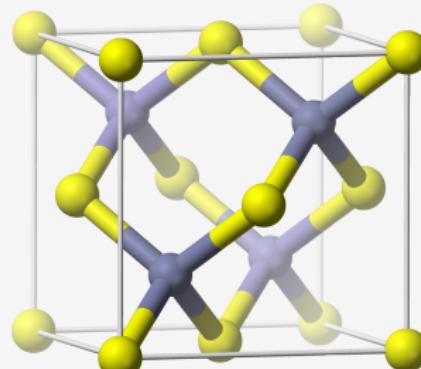


M. Ohring, Materials Science of Thin Films, 2nd ed. San Diego: Elsevier Science, 2001.

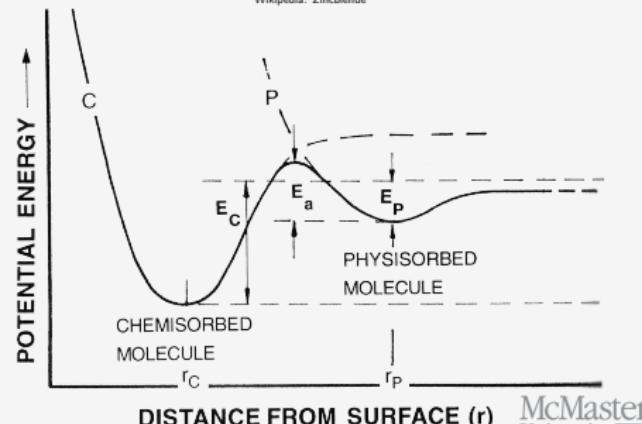
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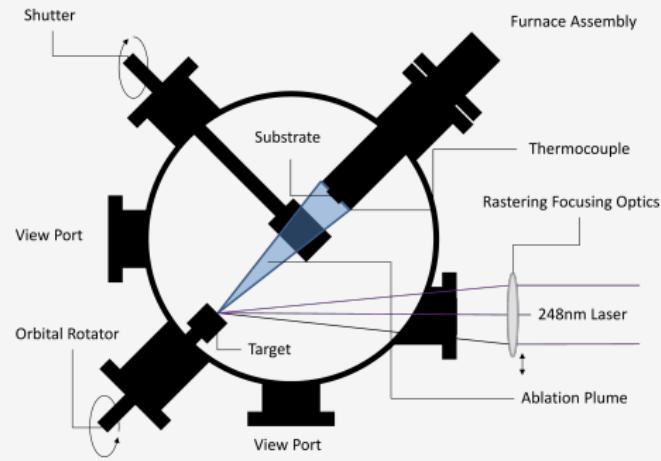
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McMaster University

Experimental

Unusual Bond Energies

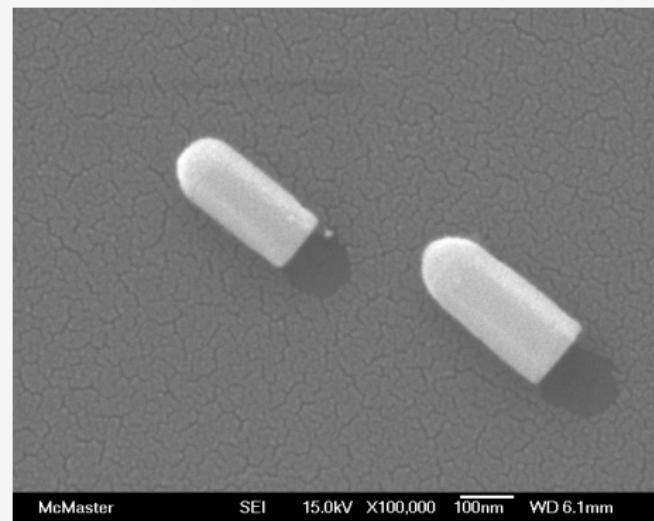
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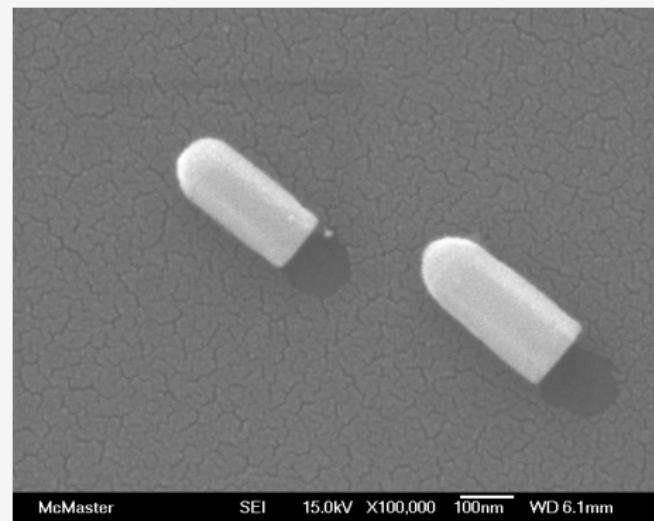
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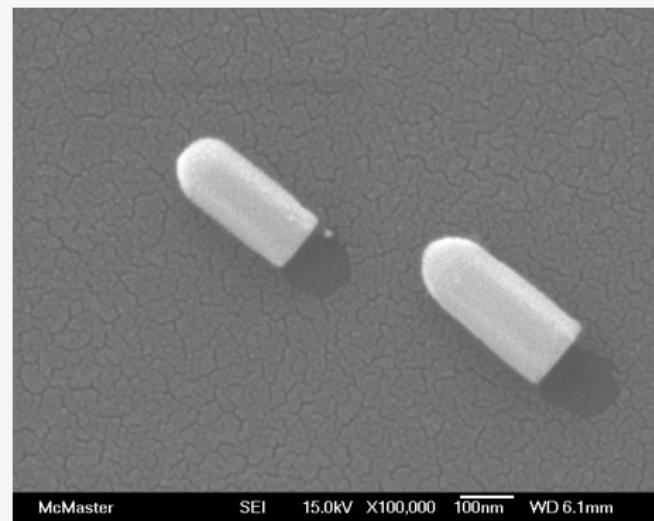
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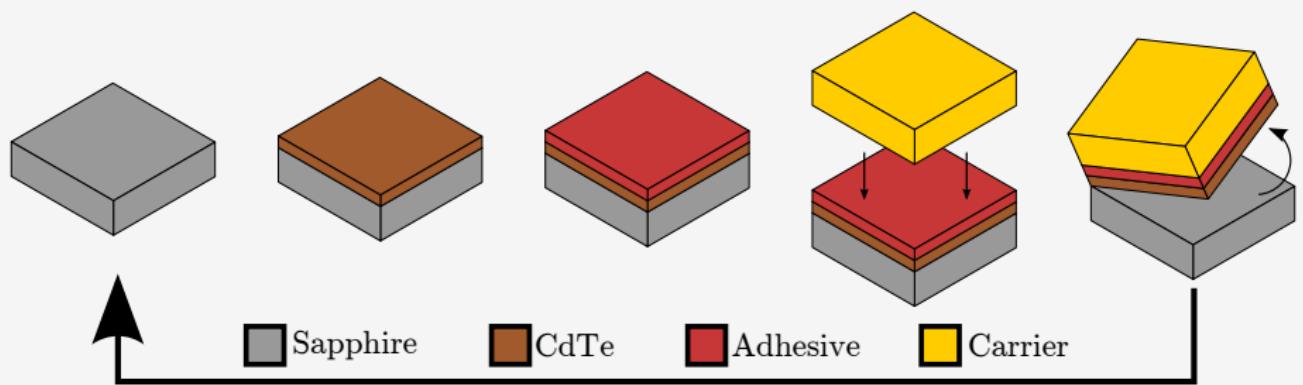
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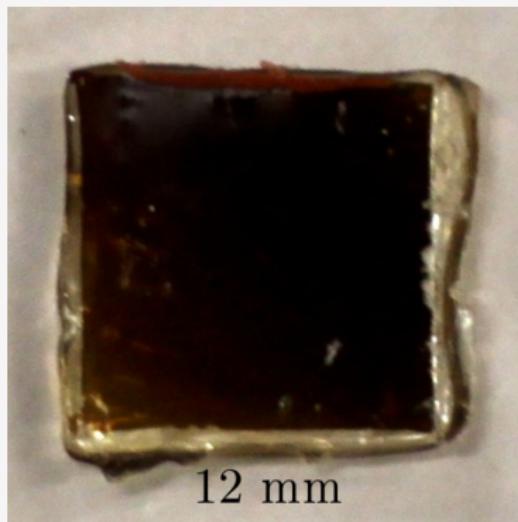
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The Process

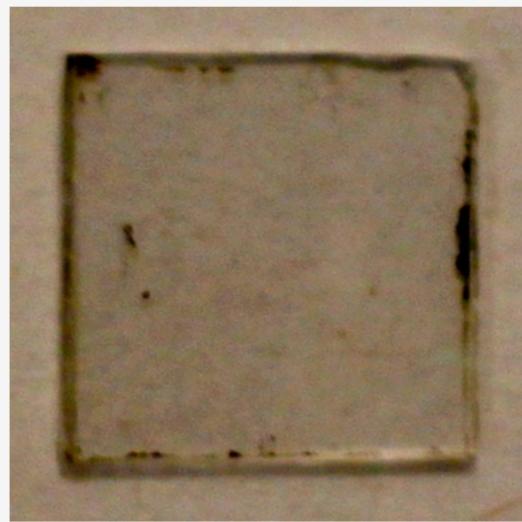


Practical Results



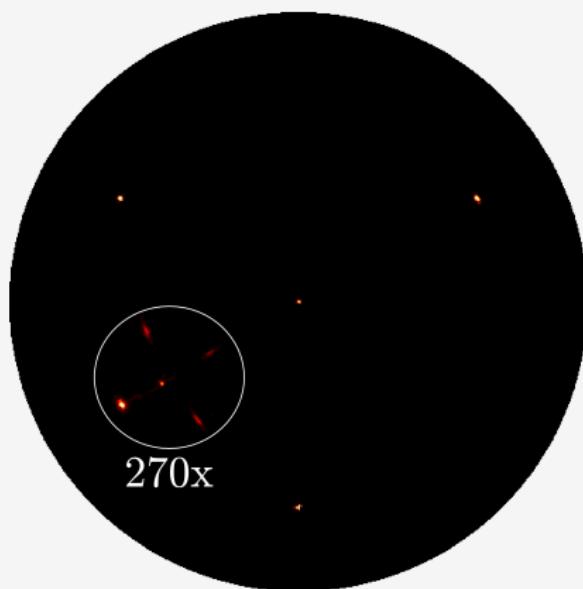
12 mm

CdTe on Optical Adhesive Carrier

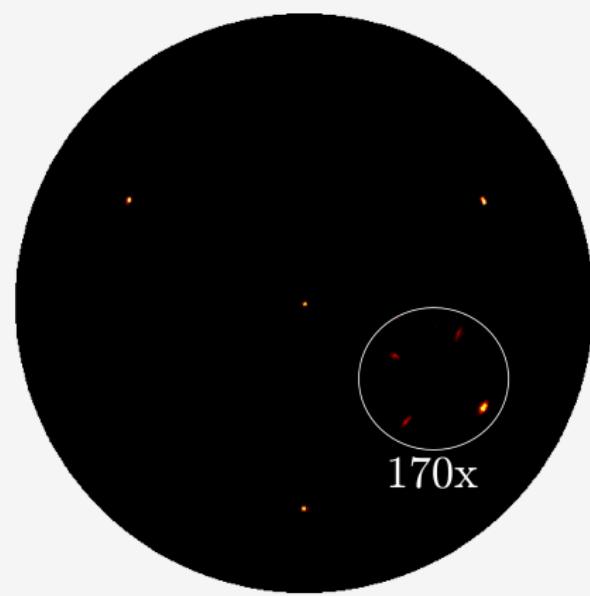


(Mostly) Clean Sapphire Substrate

2DXRD Results



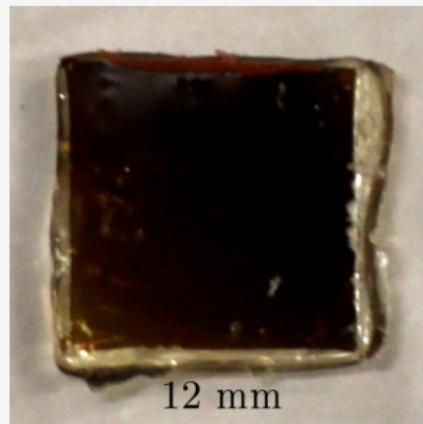
CdTe on Sapphire (111) Pole Figure



CdTe Liftoff on Epoxy Carrier

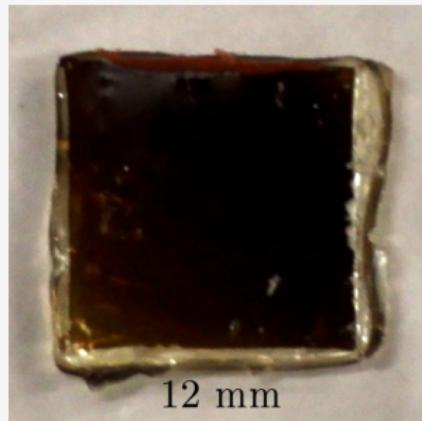
Results

- Liftoff process is near 100% effective, subject to better processing
- Liftoff is not destructive to crystal structure
- Liftoff relieves strain in CdTe, improving X-ray peak widths
- Leftover sapphire substrate is suitable for CdTe growths (after cleaning)



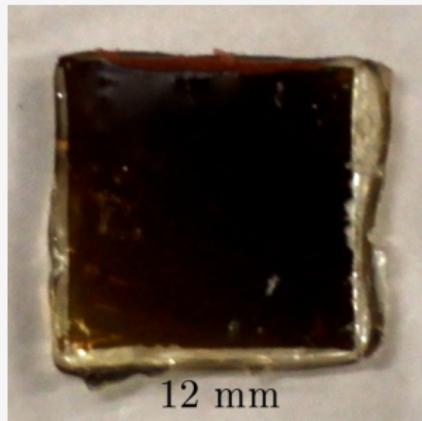
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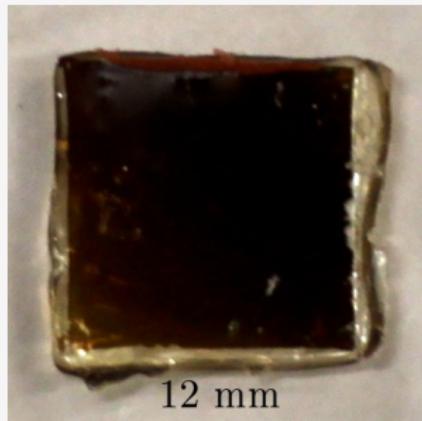
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Results and Conclusions

■ Symmetry and Symmetry Breaking

- Vicinal substrates influence thin film growth through asymmetric enhancements of growth rate
- Naturally asymmetric surfaces allow for strain accommodation through tilt during epitaxy

■ Unusual Bond Energies at Interfaces

Unusual bond energies at interfaces can lead to anomalous epitaxial relationships.

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 - Chemically dissimilar epitaxy results in a new phenomenon of tilt with potential engineering applications

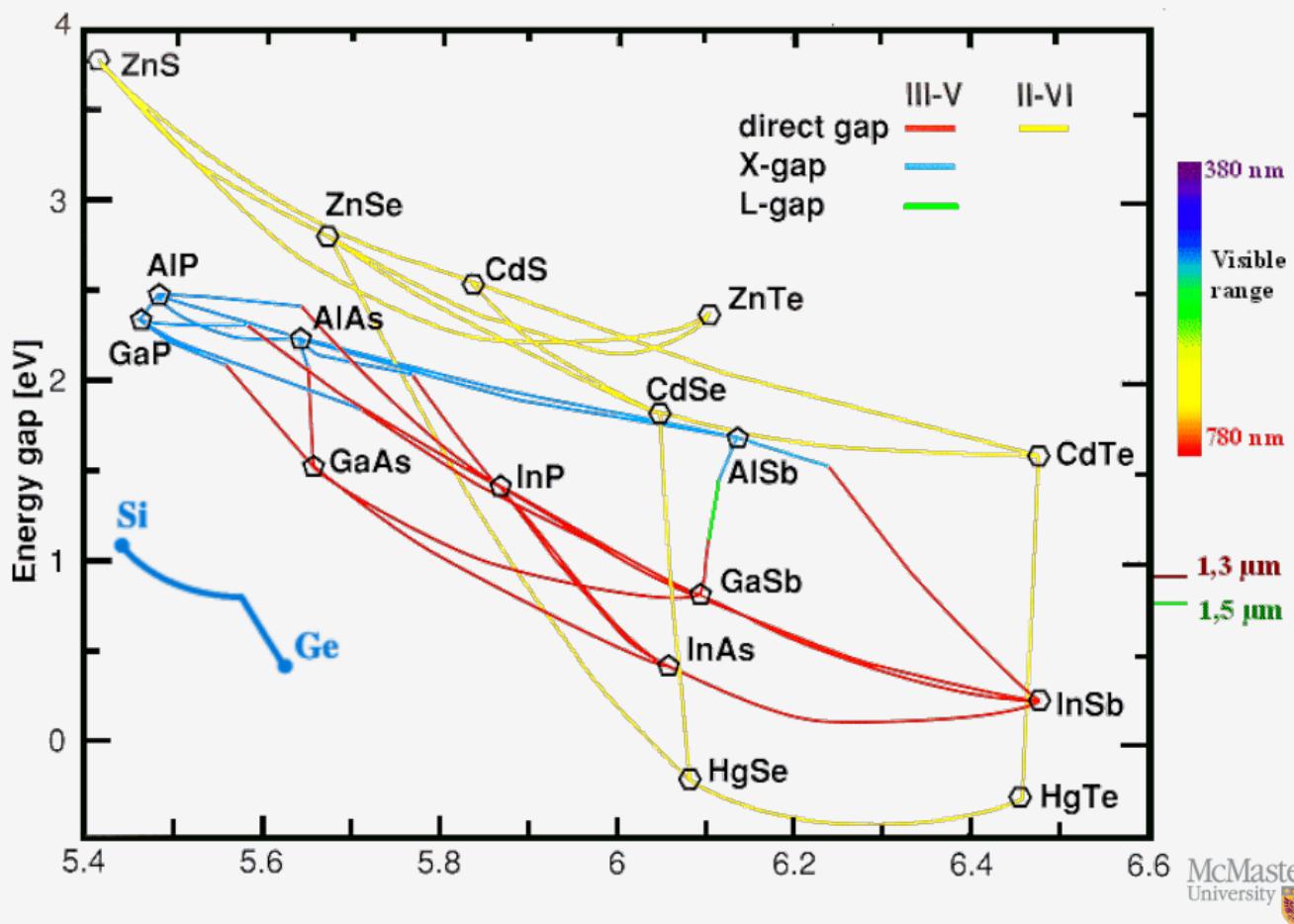
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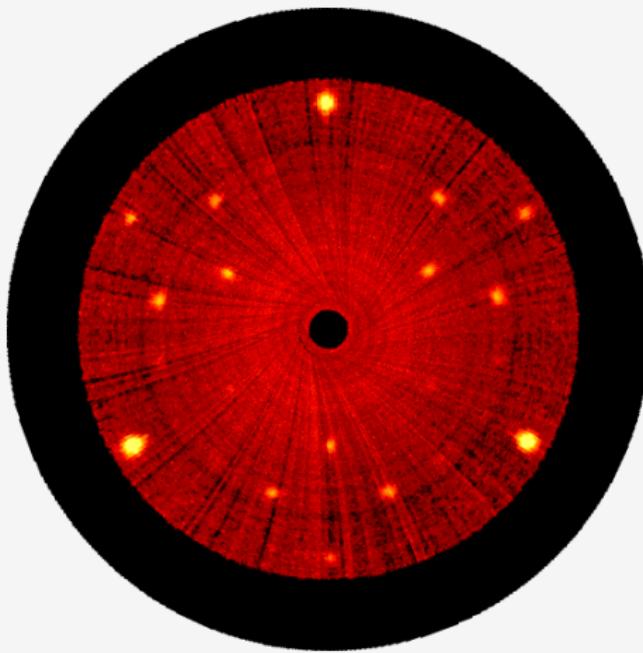
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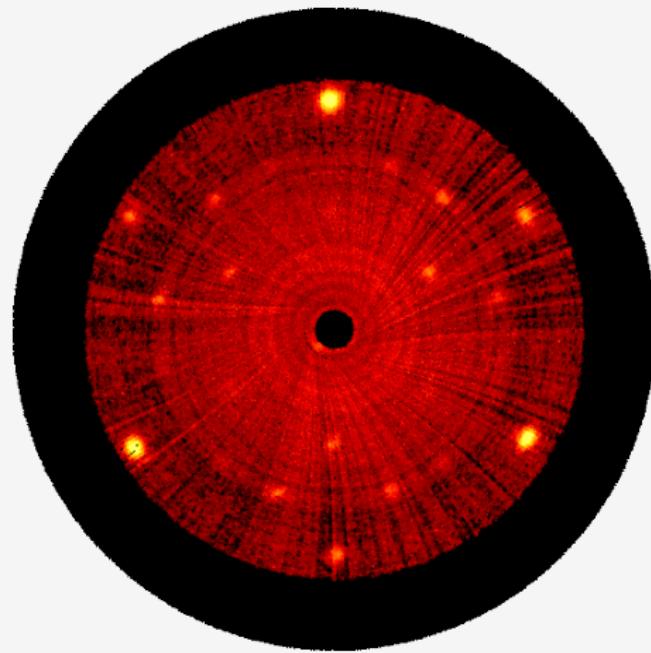
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Thank You



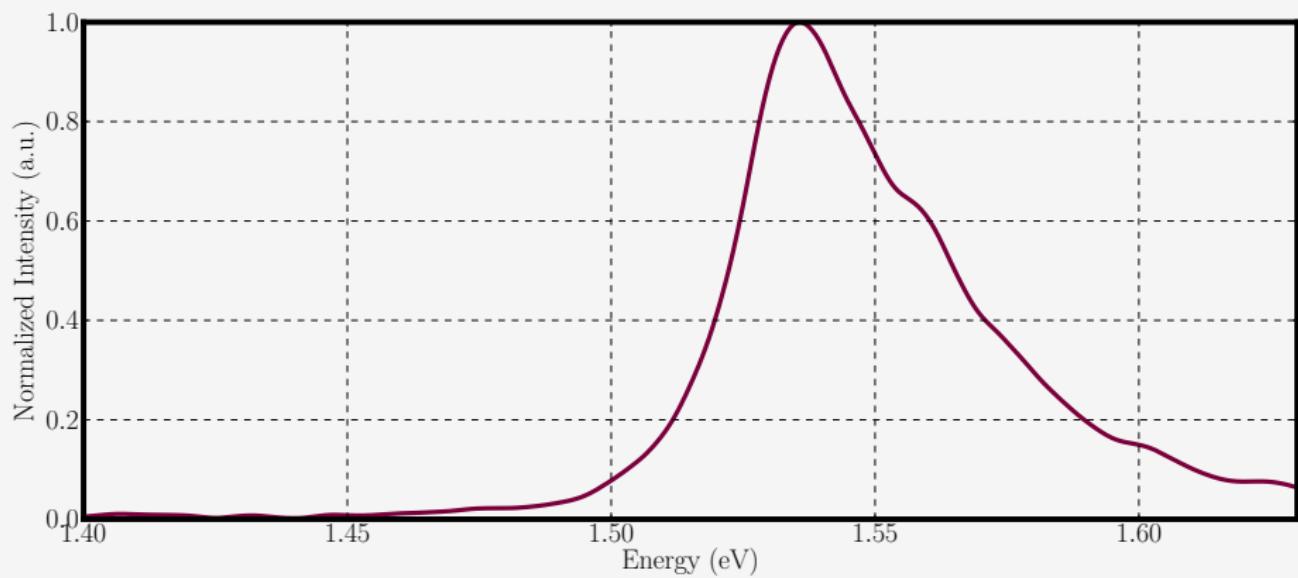


InSb on Sapphire



InSb on Epoxy Carrier

Low Temperature Photoluminescence



Low Temperature Photoluminescence

